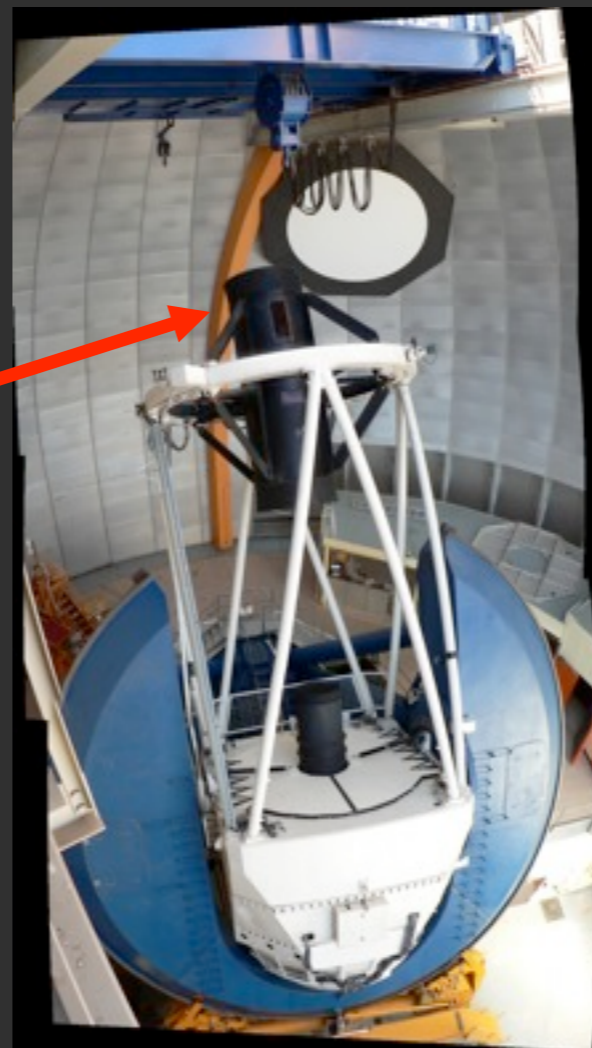
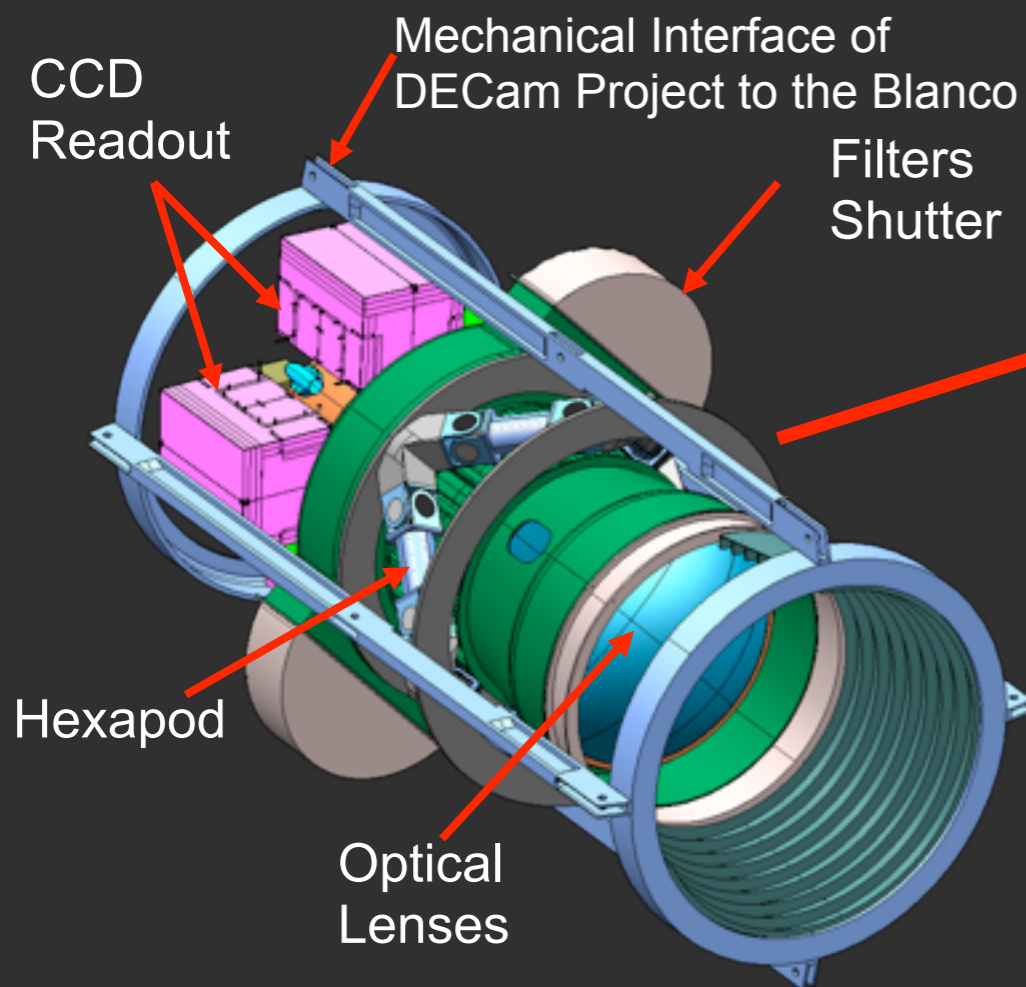


Low threshold DM search using Charge Coupled Devices. DAMIC

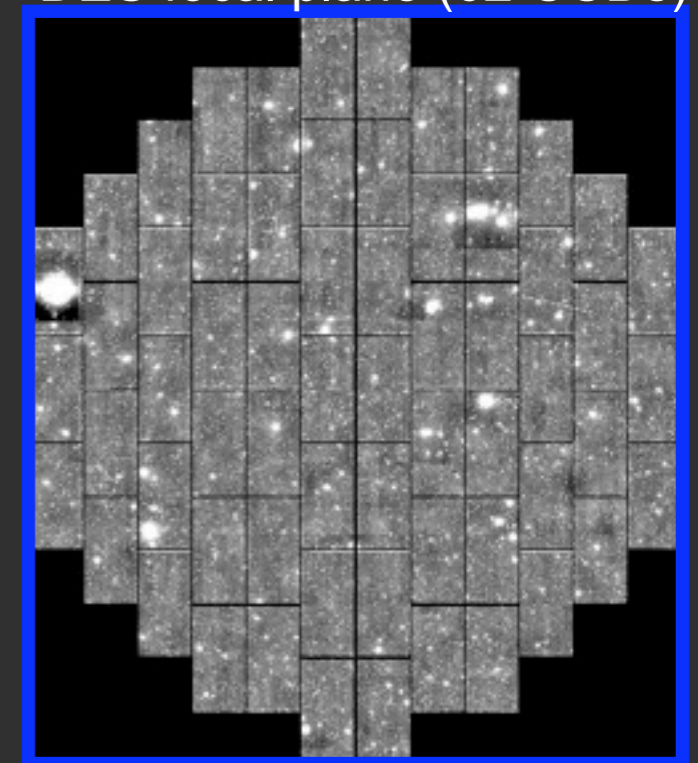
Juan Estrada
Fermilab

Dark Energy Camera (DECam)

New wide field imager (3 sq-deg) for the Blanco 4m telescope to be delivered in 2010 in exchange for 30% of the telescope time during 5 years. Being built at FNAL.



DES focal plane (62 CCDs)



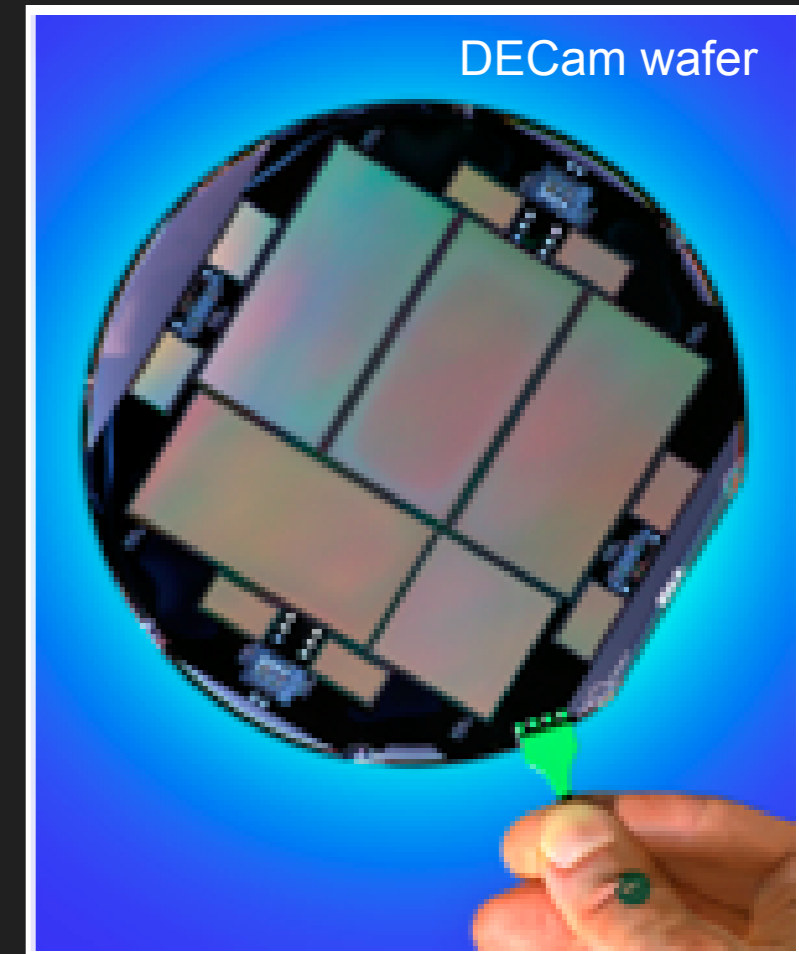
DECam focal plane detectors

Science goal requires DES to reach $z \sim 1$

for DES we want to spend $\sim 50\%$ of time in z -filter (825-1100nm)
 Astronomical CCDs are usually thinned to 30-40 microns (depletion):
 Good 400nm response
 Poor 900nm response

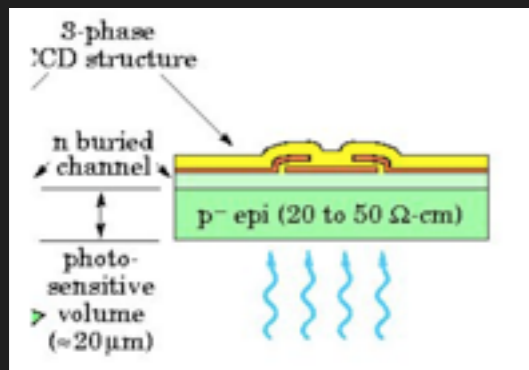
LBL full depletion CCD are the choice for DECam:

- 250 microns thick
- high resistivity silicon
- QE > 50% at 1000 nm

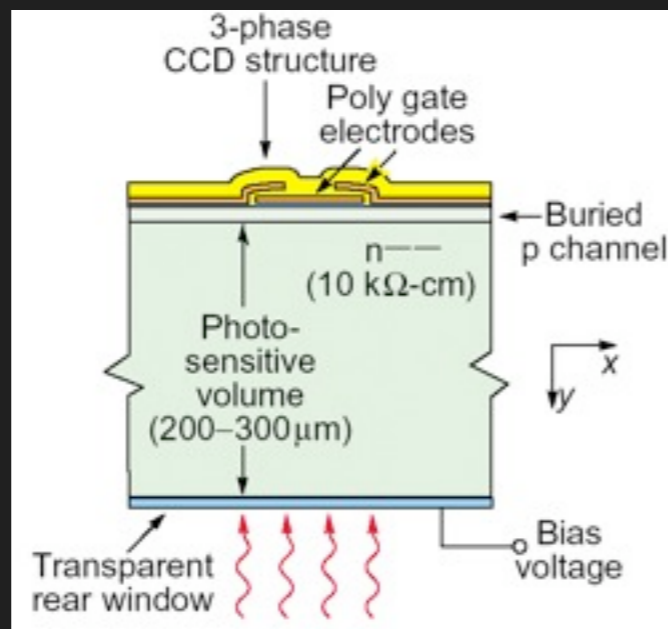


DECam wafer

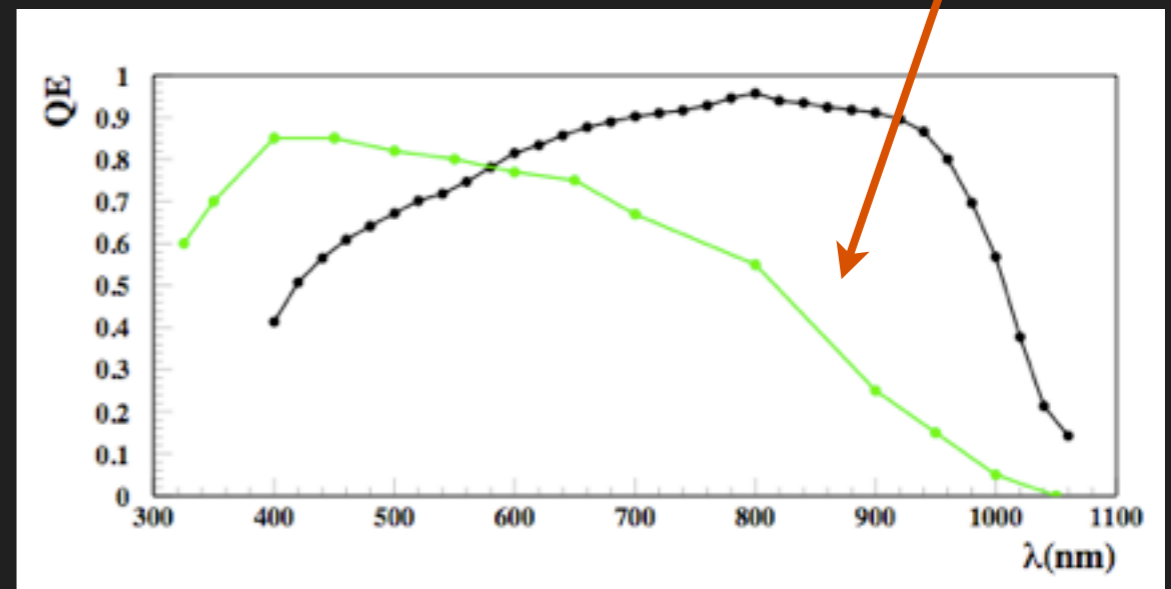
typical CCDs



new thick CCDs

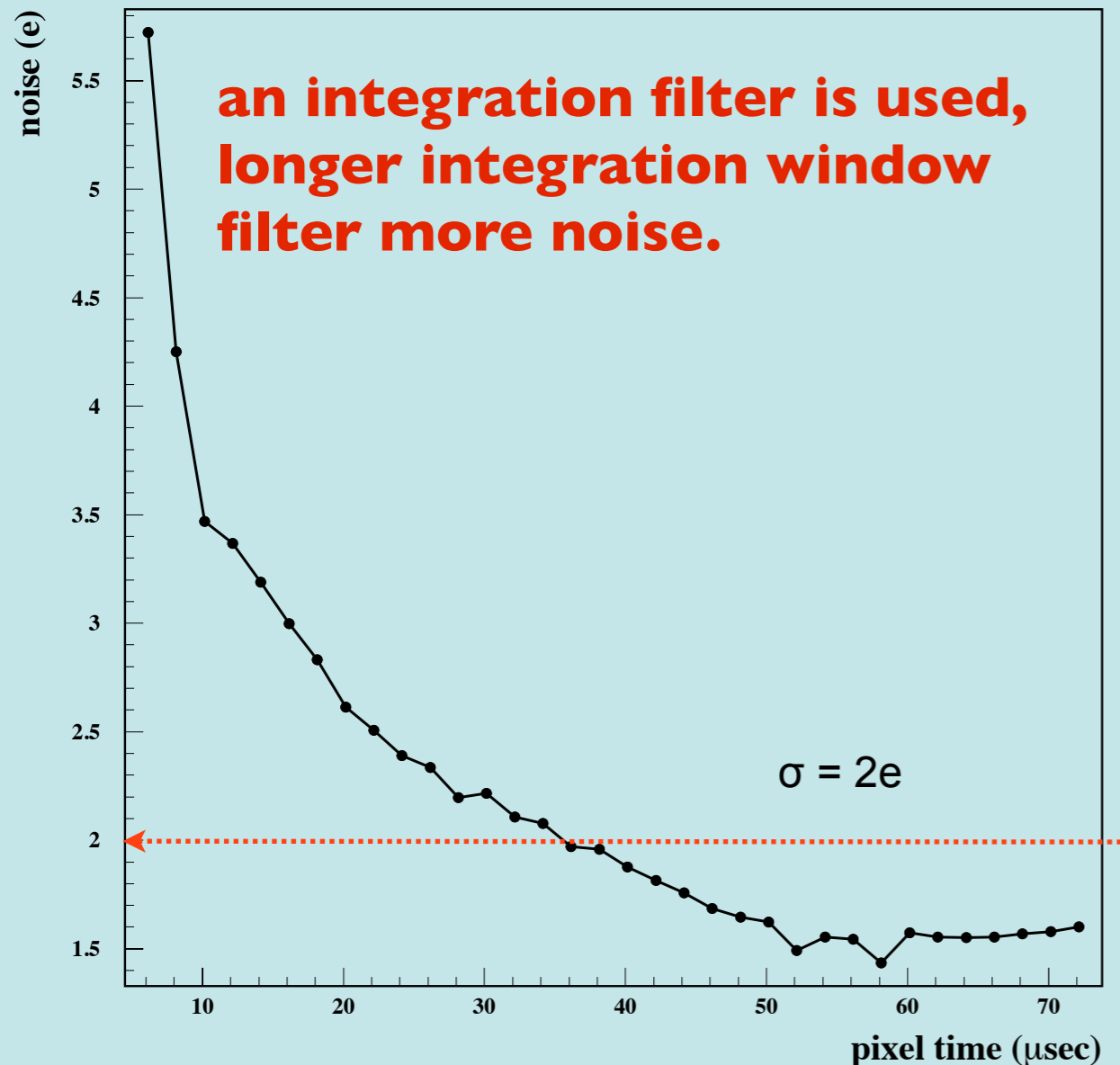


higher efficiency for hi-z objects.



New opportunities with these CCDs

**an integration filter is used,
longer integration window
filter more noise.**



Two features:

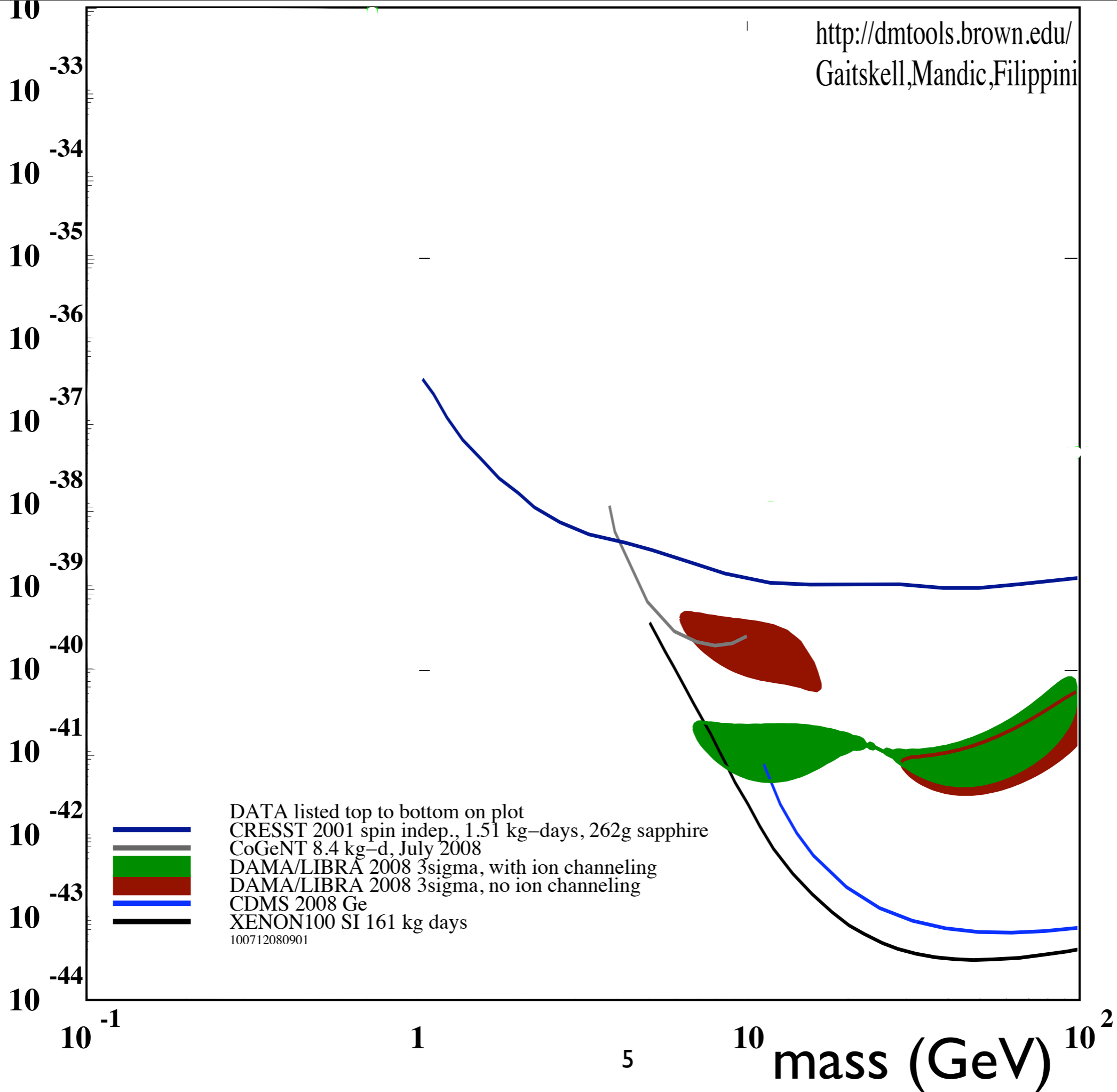
CCDs are readout serially (2 outputs for 8 million pixels). When readout slow, these detectors have a noise below $2e^-$ (RMS). This means an **RMS noise of 7.2 eV in ionization energy!**

The devices are “massive”, 1 gram per CCD. Which means you could easily build ~ 10 g detector. **DECam is a 70g detector.**

Interesting for a low threshold DM search.








- 7.2 eV noise \Rightarrow low threshold (~ 0.036 keVee)
- 250 μm thick \Rightarrow reasonable mass (a few grams detector)

cross section (cm²)



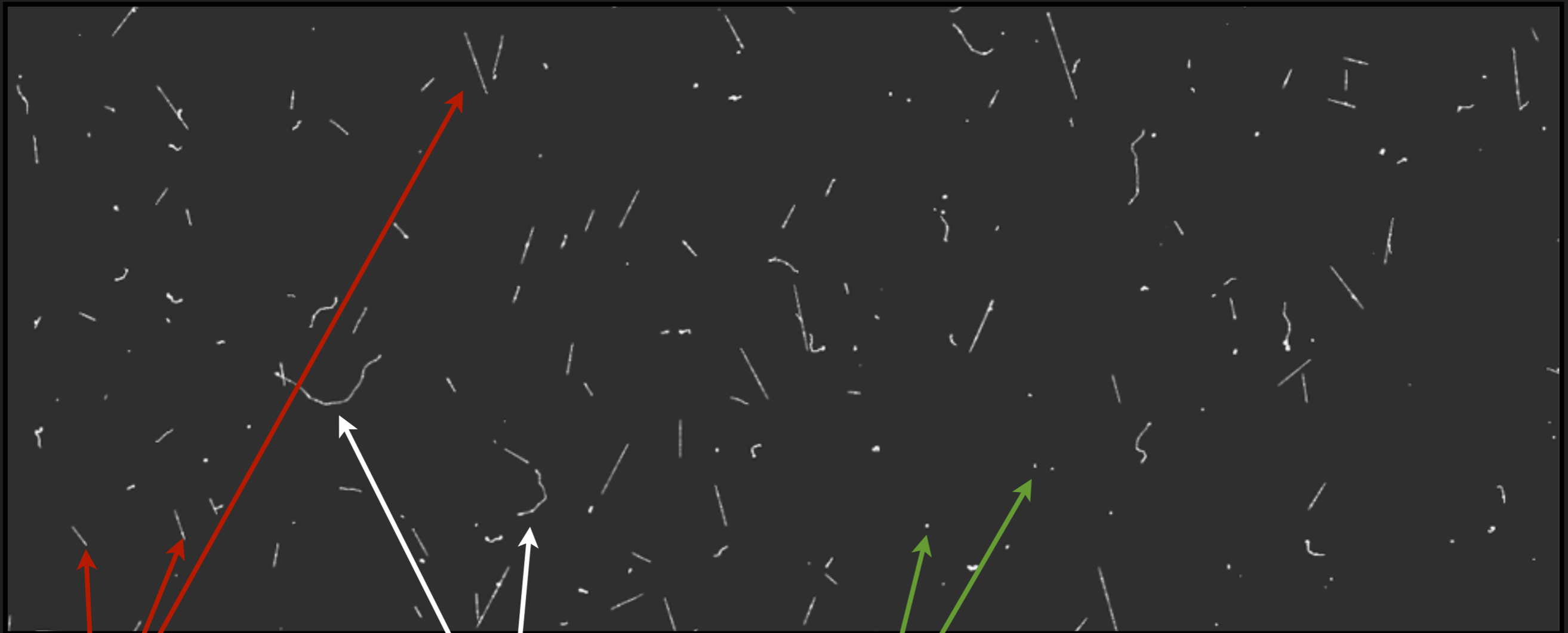
cross section (cm²)

**an experiment
designed to
search for DM
in this region.**

-  DATA listed top to bottom on plot
 -  CRESST 2001 spin indep., 1.51 kg-days, 262g sapphire
 -  CoGeNT 8.4 kg-d, July 2008
 -  DAMA/LIBRA 2008 3sigma, with ion channeling
 -  DAMA/LIBRA 2008 3sigma, no ion channeling
 -  CDMS 2008 Ge
 -  XENON100 SI 161 kg days
- 100712080901

10⁻¹ 1 6 10¹ 10²
mass (GeV)

Radiation in CCDs



muons, electrons and diffusion limited hits.

nuclear recoils will produce diffusion limited hits

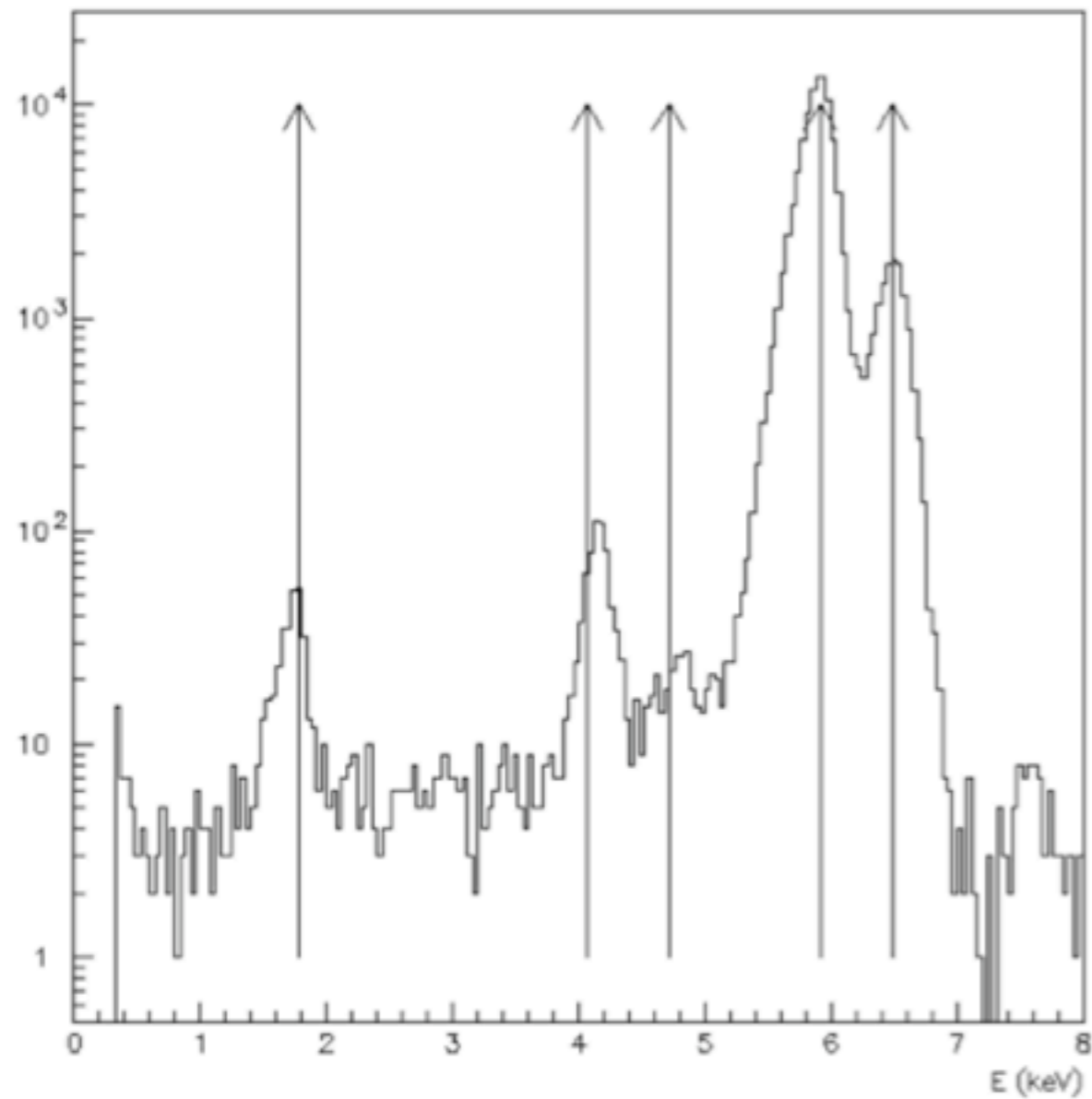
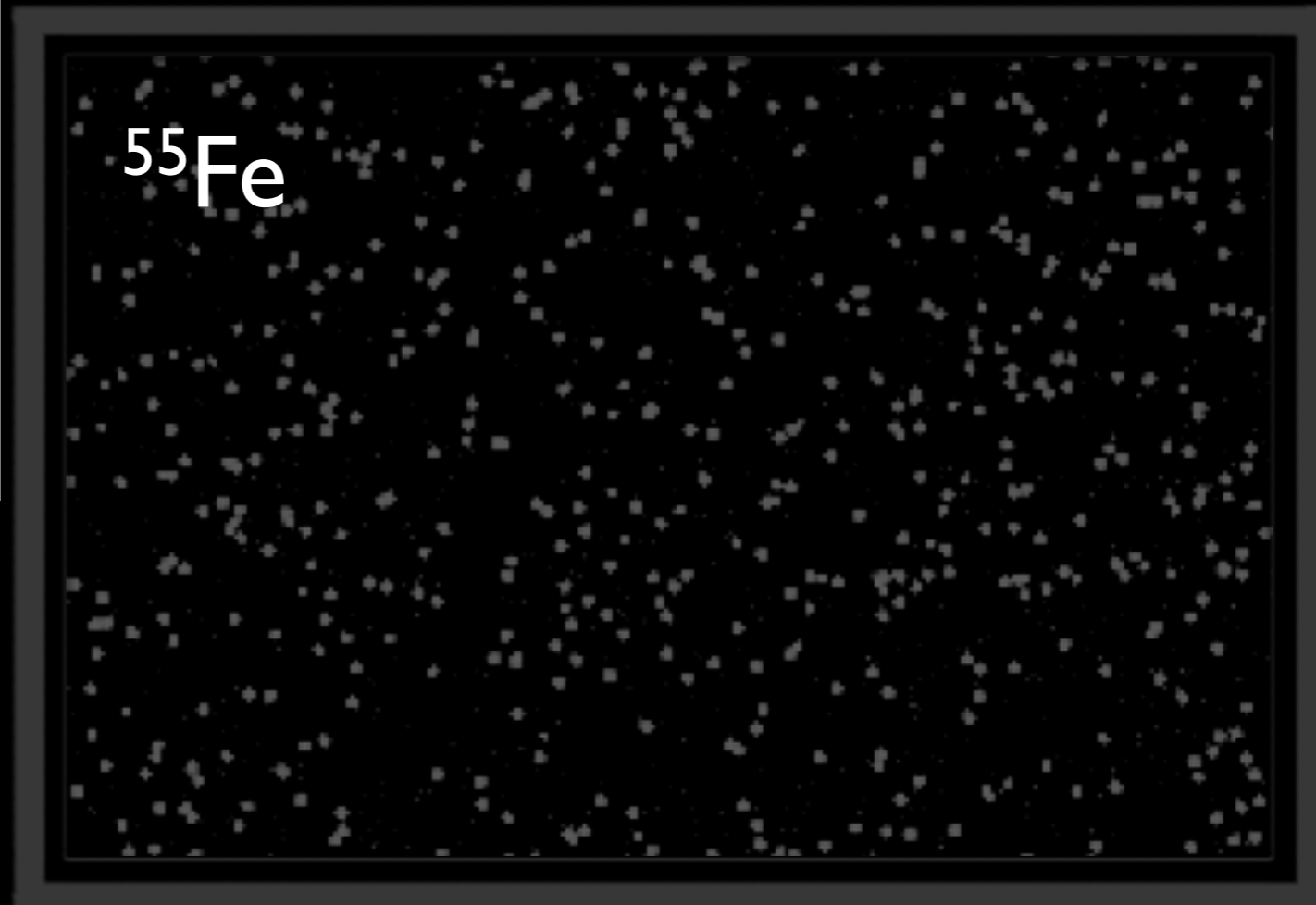
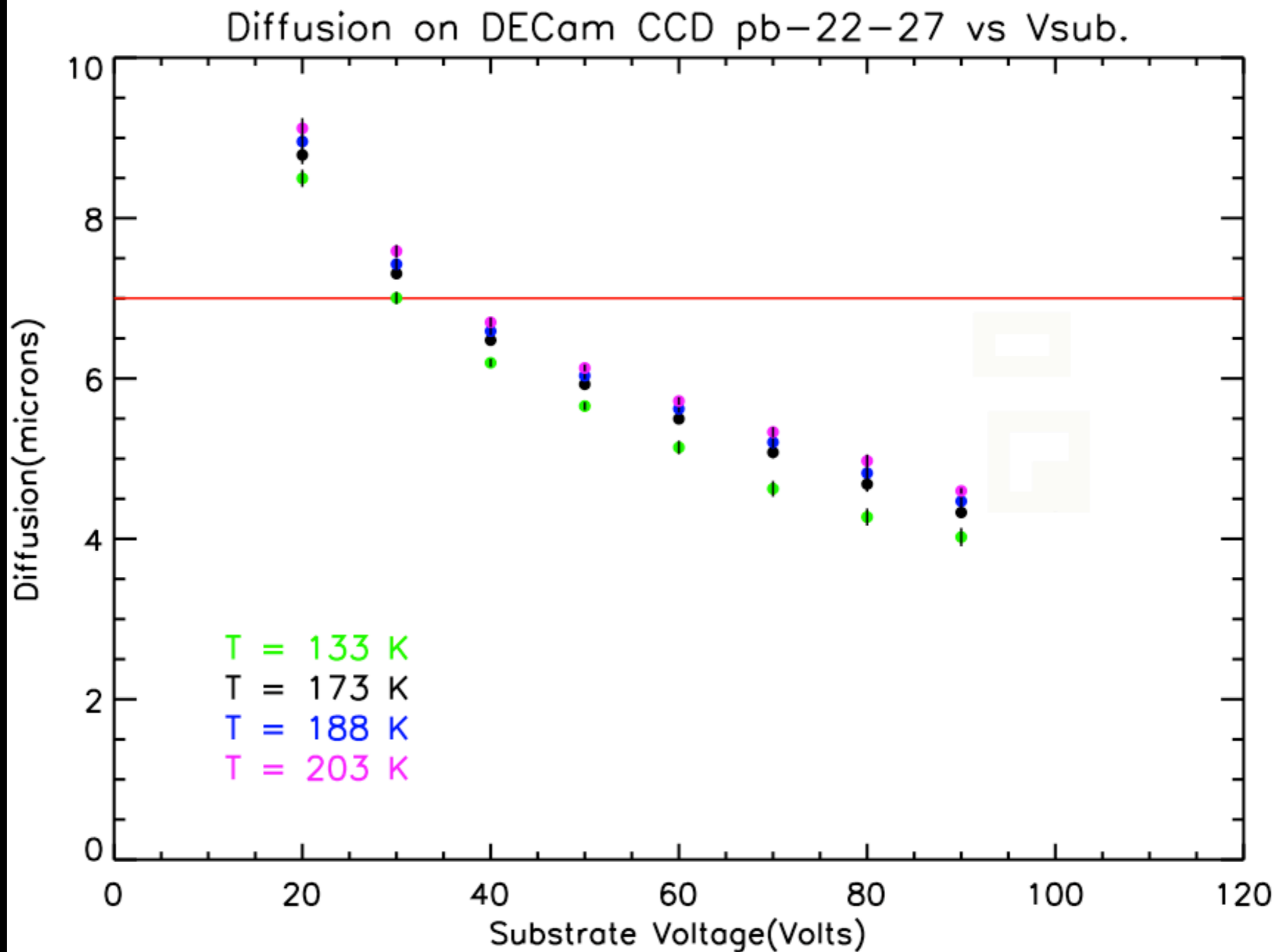


Figure 8. Spectrum obtained for the reconstructed X-ray hits in an ^{55}Fe exposure of a DECam CCD. The arrows are marking the direct X-rays from the source $K_{\alpha}=5.9$ keV and $K_{\beta}=6.5$ keV. K_{α} and K_{β} escape lines at 4.2 and 4.8 keV, and the Si X-ray at 1.7 keV. The factor of 3.64 eV/e $^{-}$ is used to convert from charge to ionization energy.

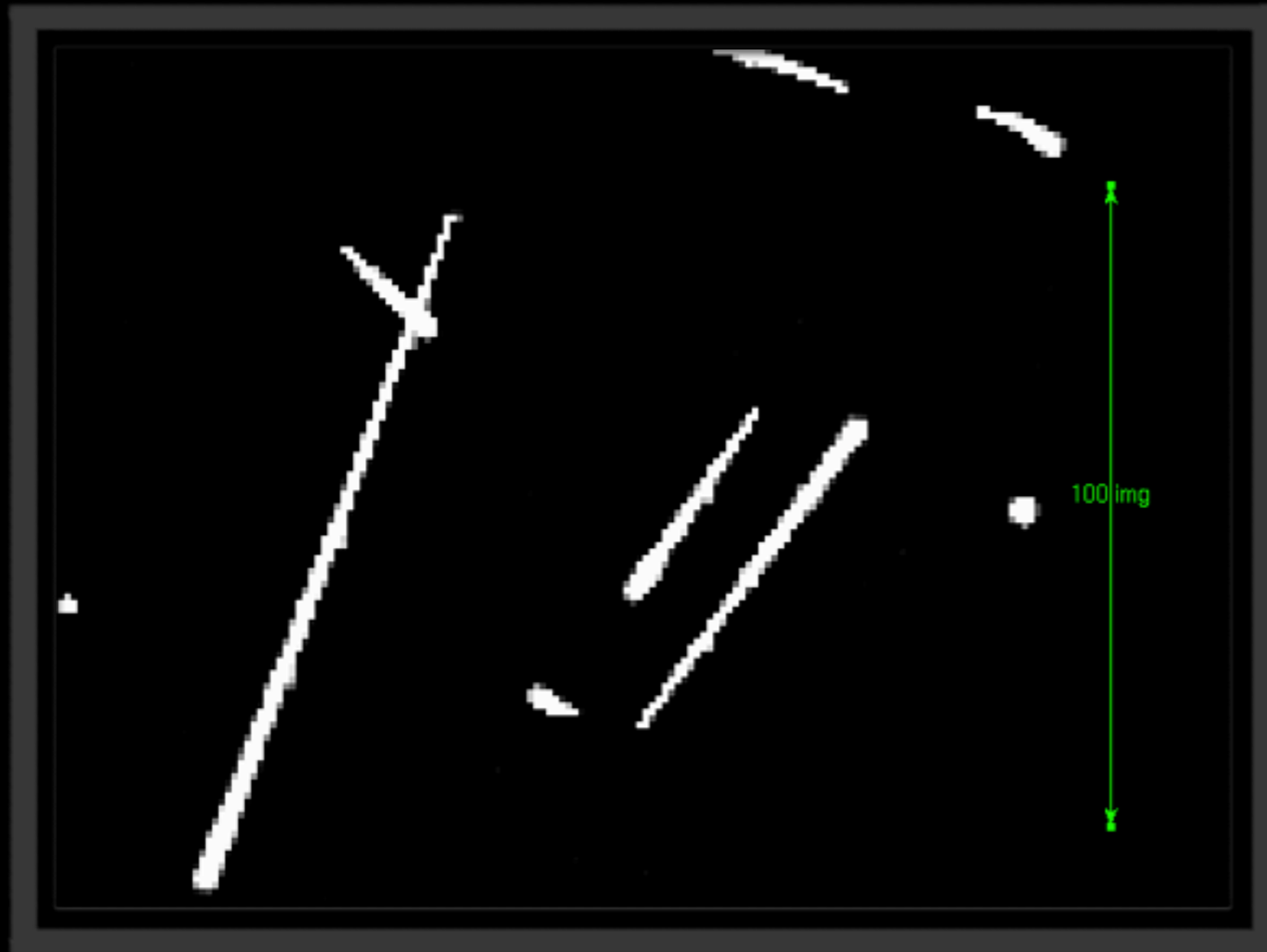
X-rays are a good way to calibrate the energy scale... and also measure diffusion.



diffusion limited hits ➤



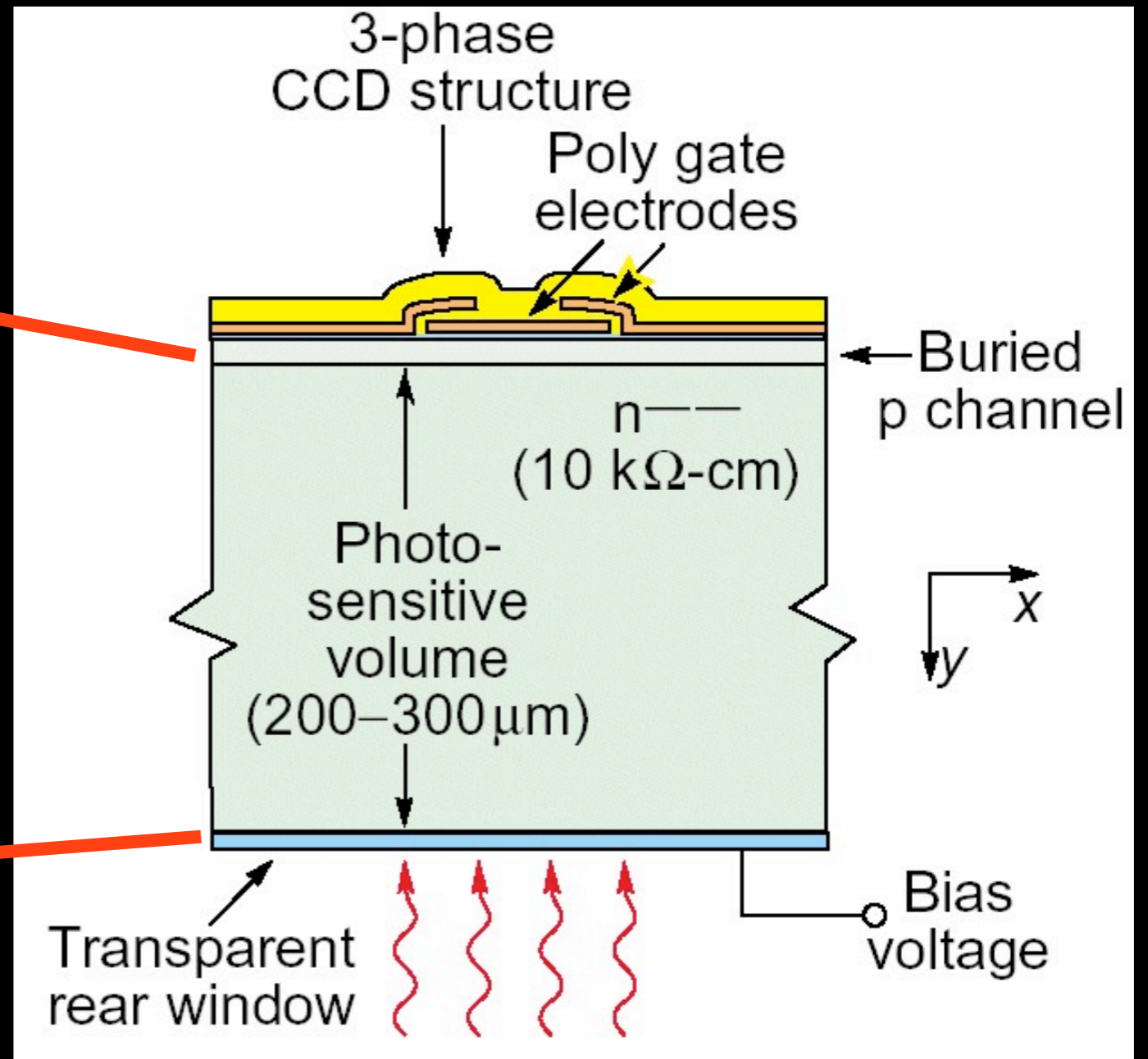
diffusion measurement using x-rays. One could simply select nuclear recoils by using the size... but there is a bit more of information.



the straight tracks
are muons

...these tracks show
the diffusion inside
the CCDs

no diffusion
close to the
gates



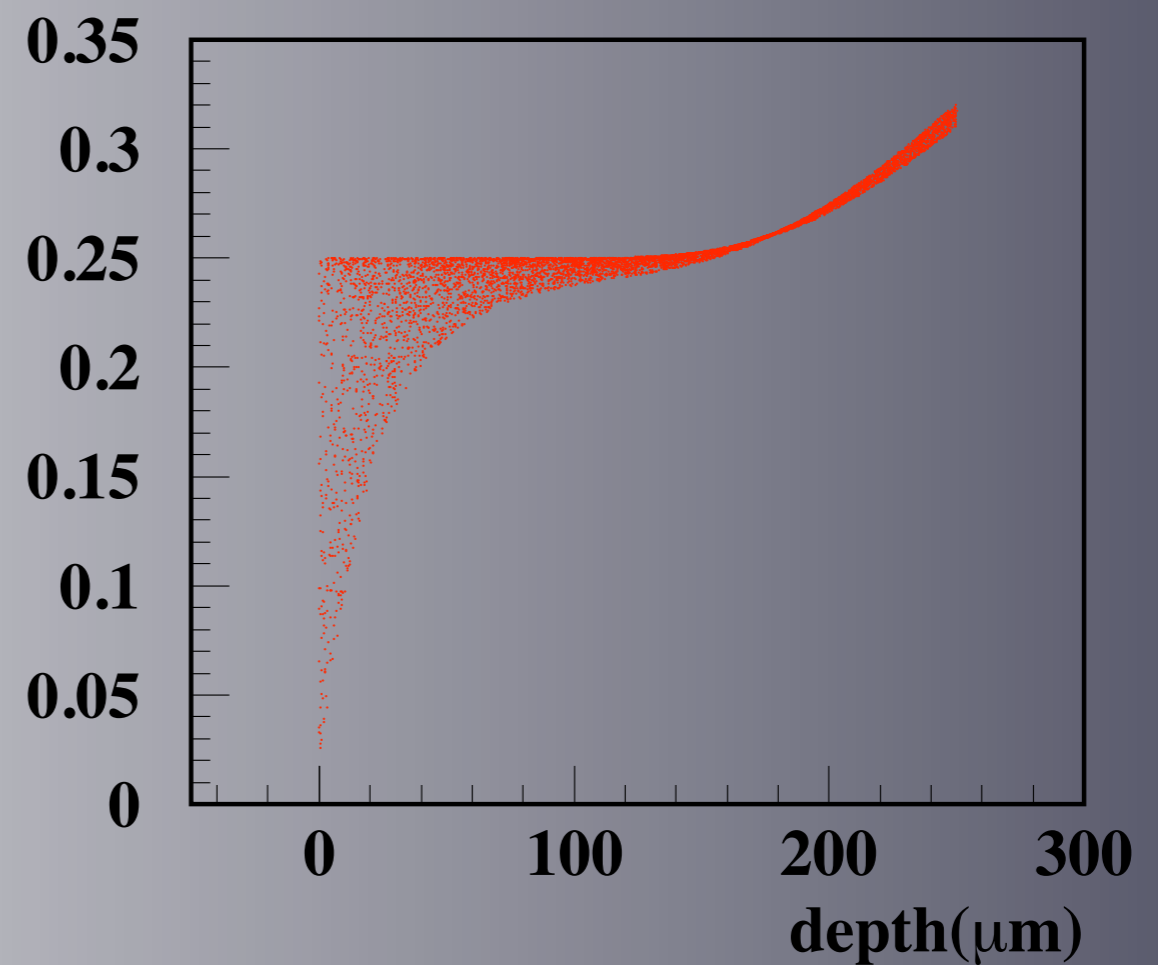
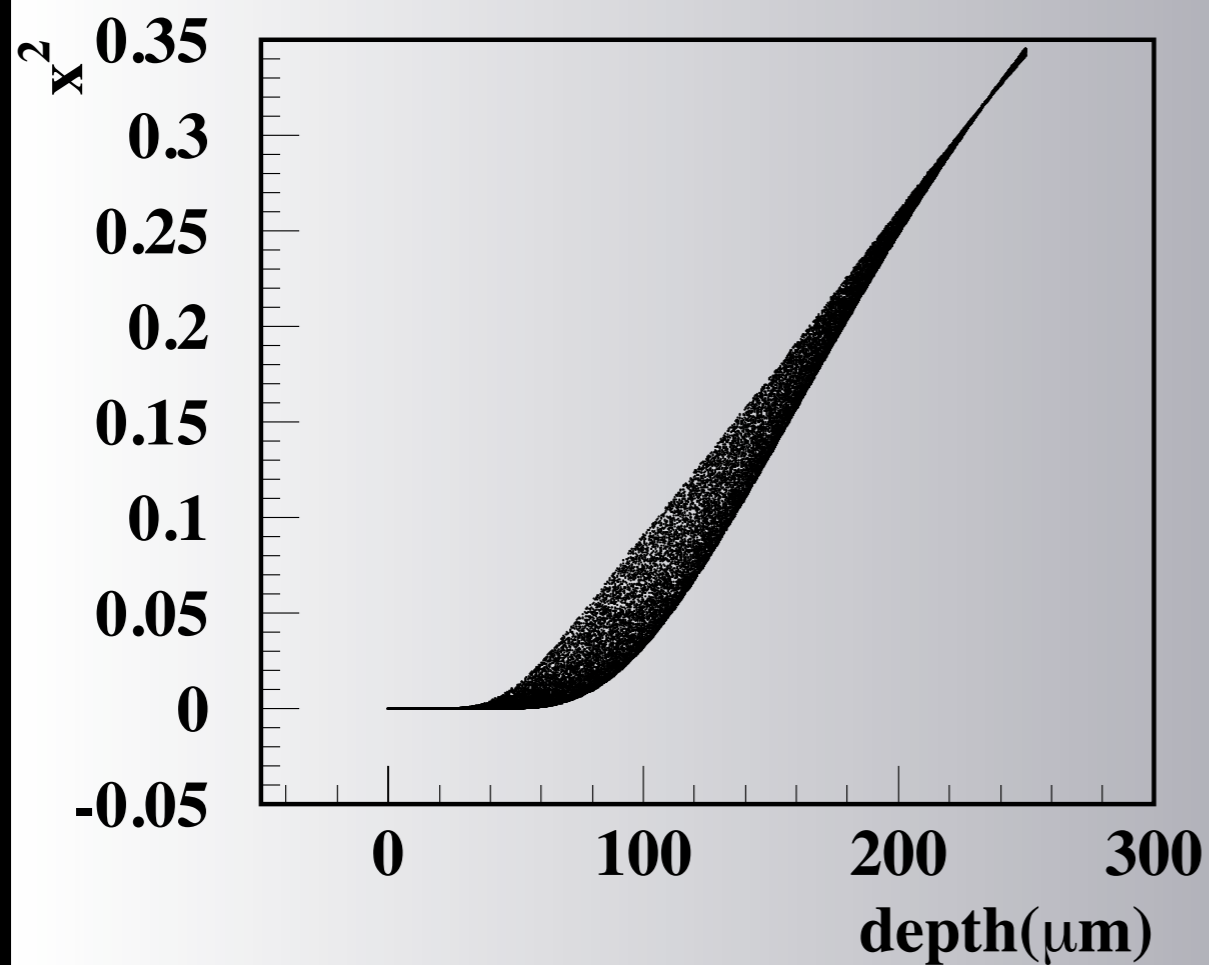
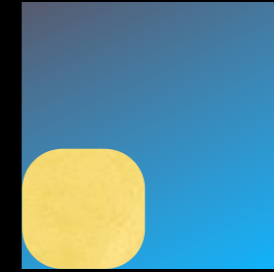
7 μm diffusion
at the back side

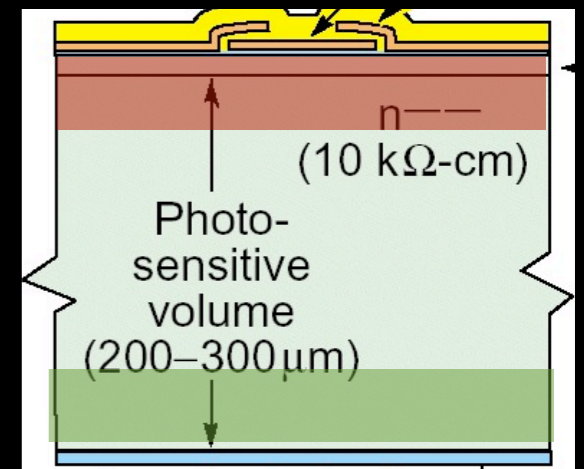
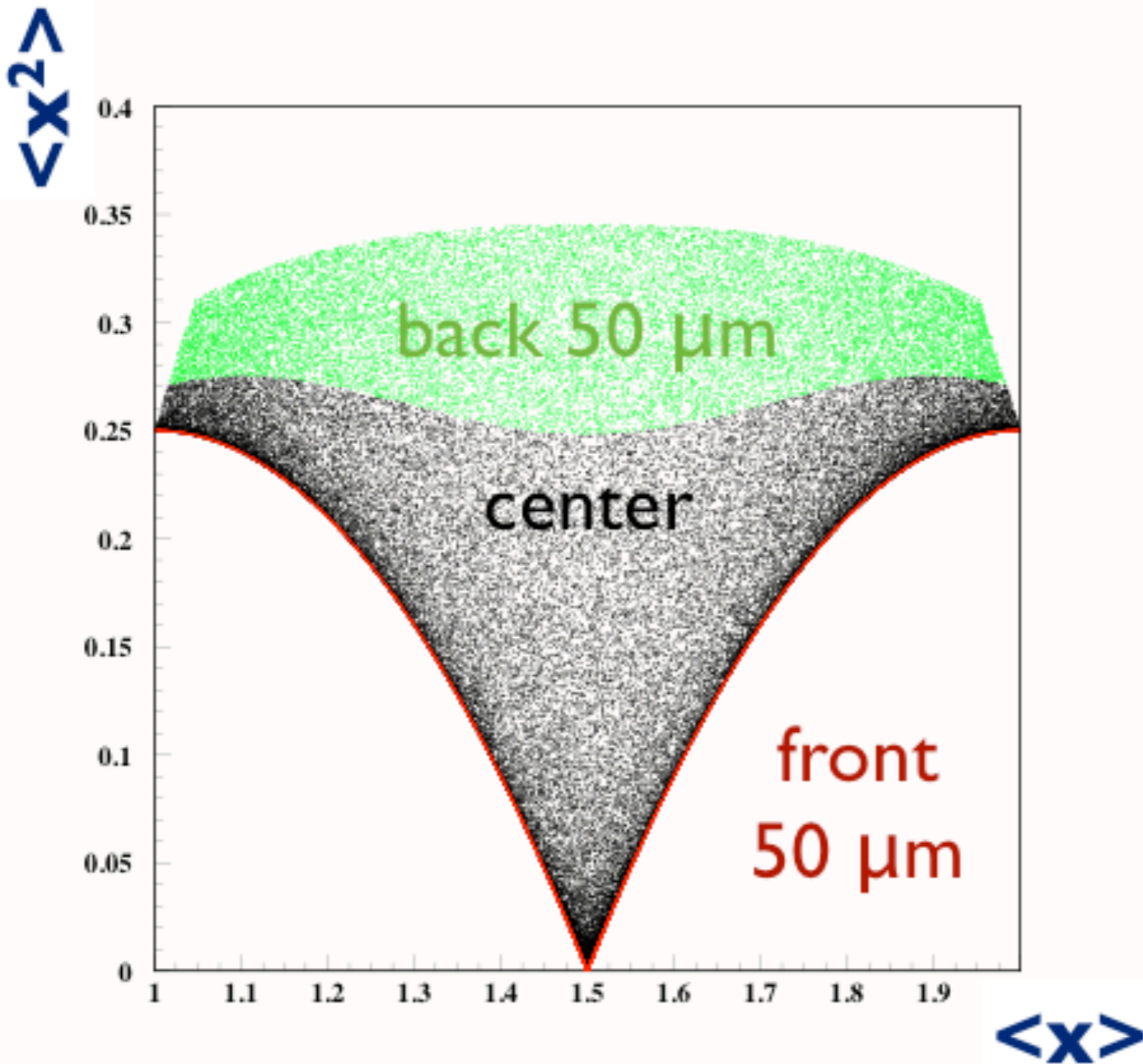
size of diffusion limited hits (simulation)

center



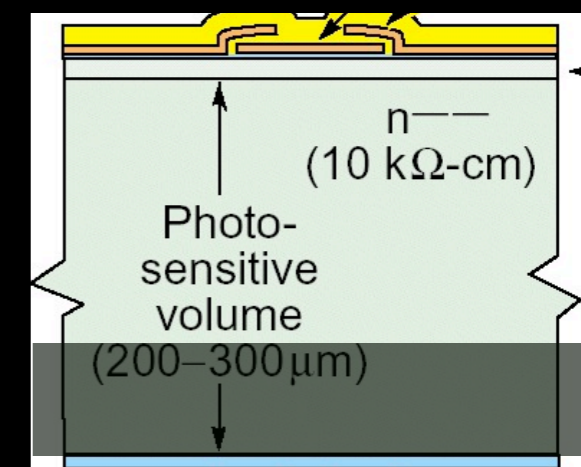
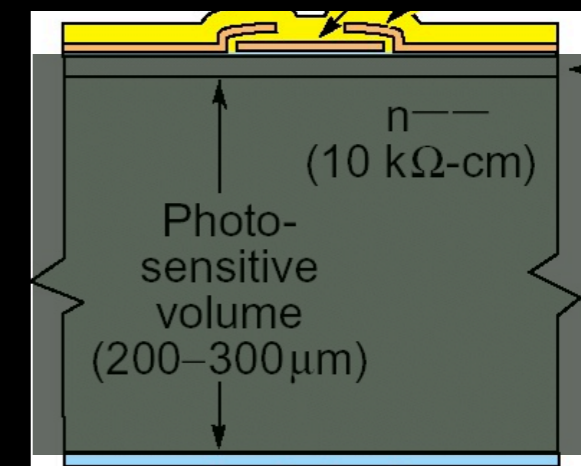
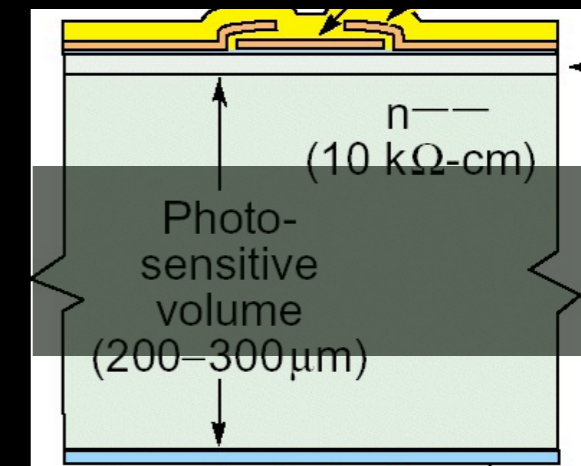
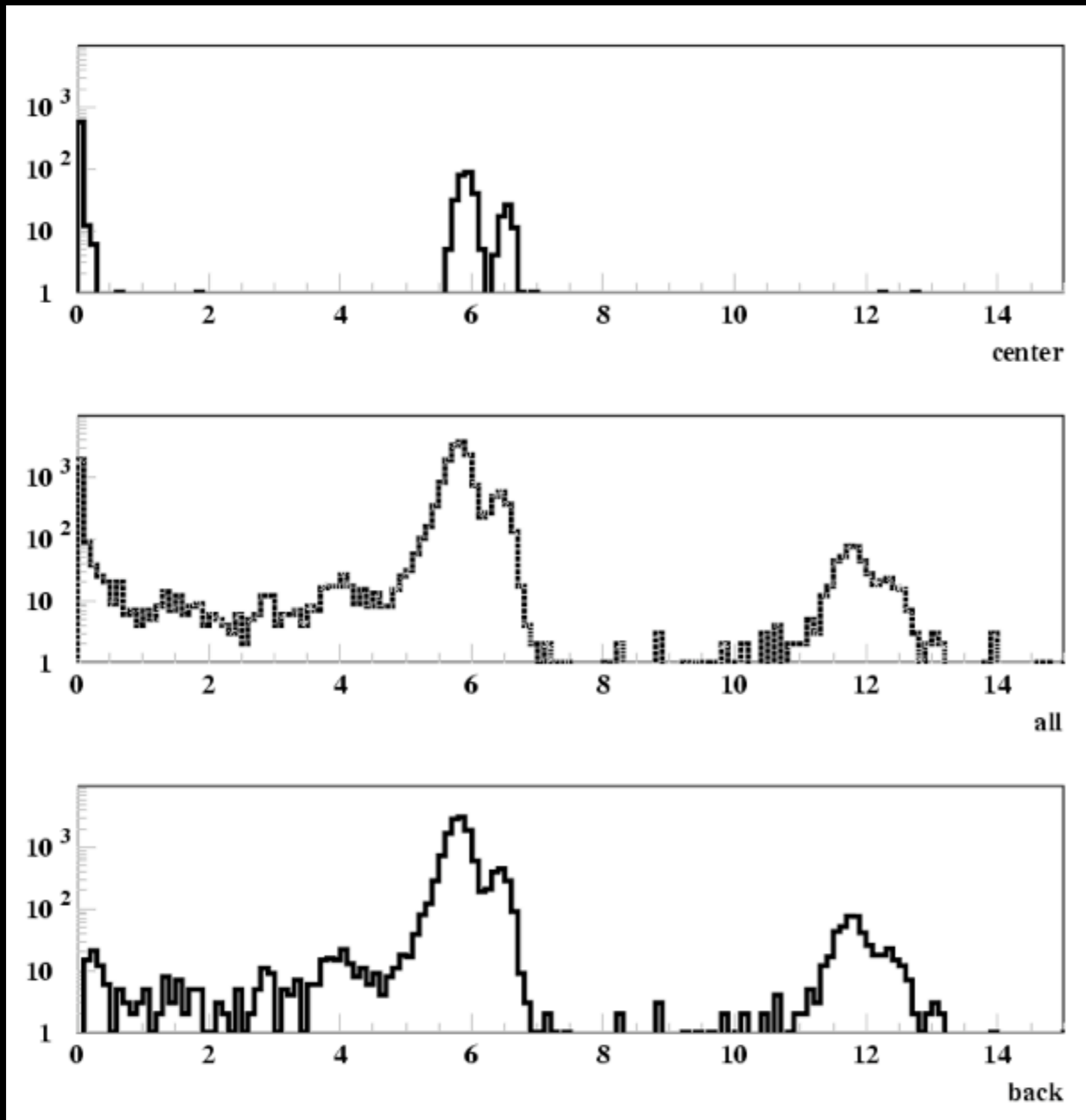
edge





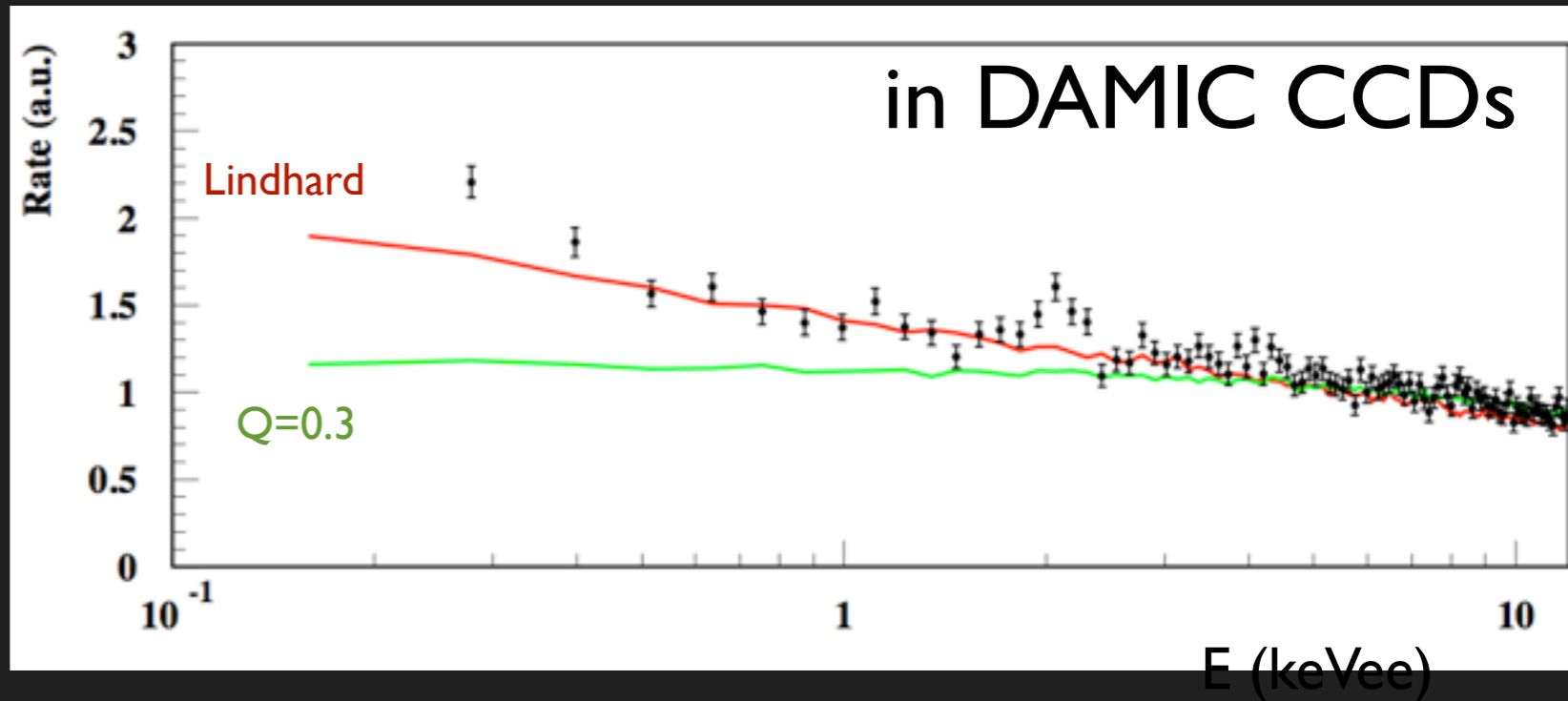
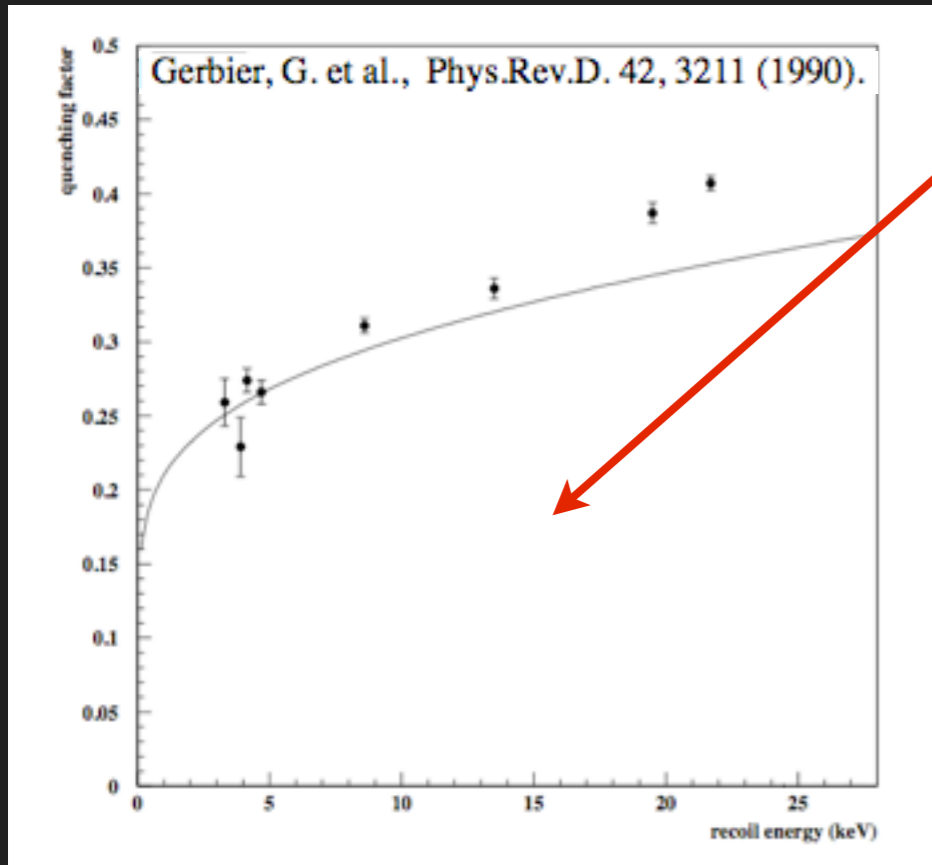
it is possible to select nuclear recoil on the bulk of the detector(cutting low energy photons on surface).

back illumination with x-rays



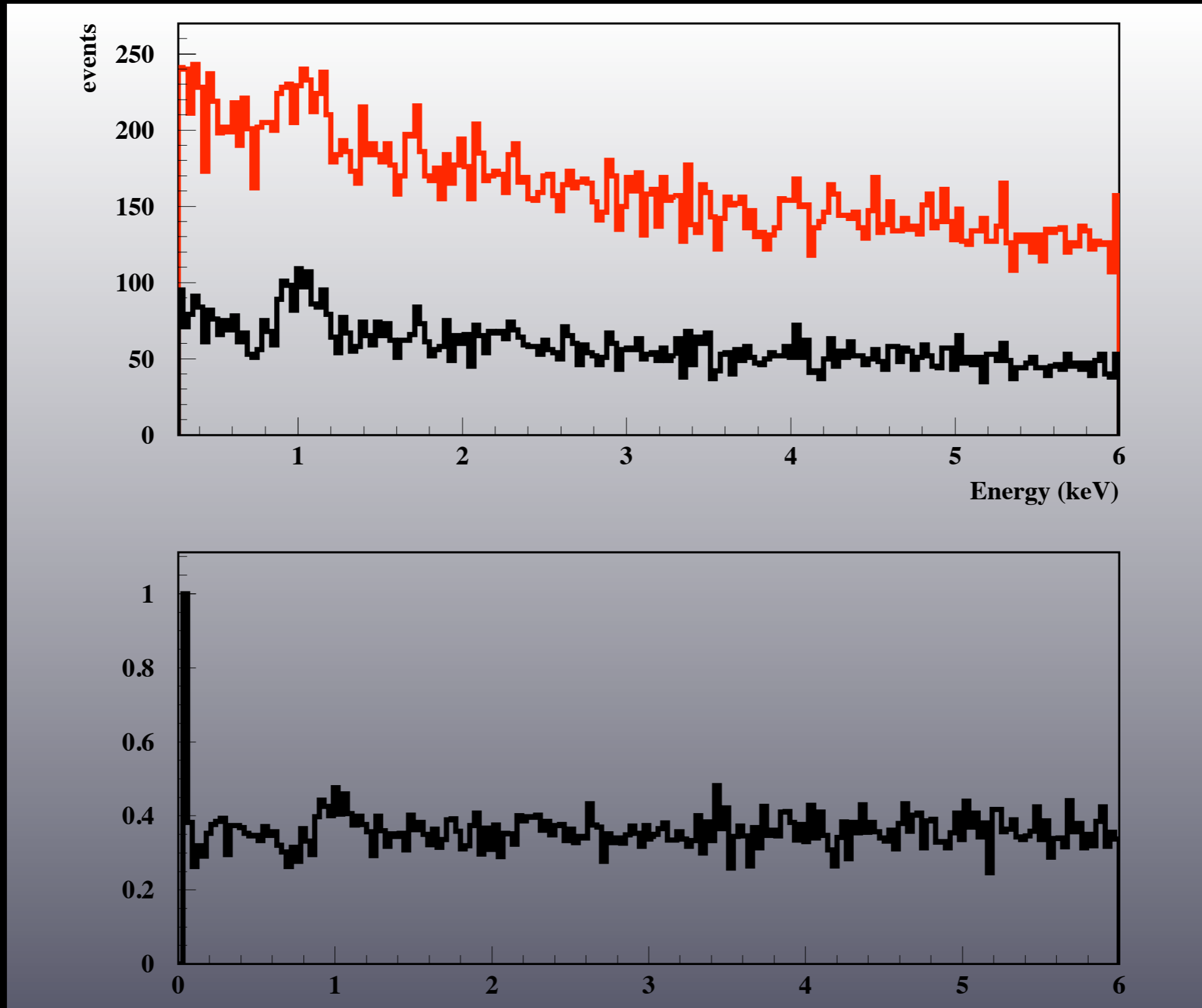
Calibration for nuclear recoils using ^{252}Cf

energy dependence measured above $E_r=4$ keV (Lindhard model)



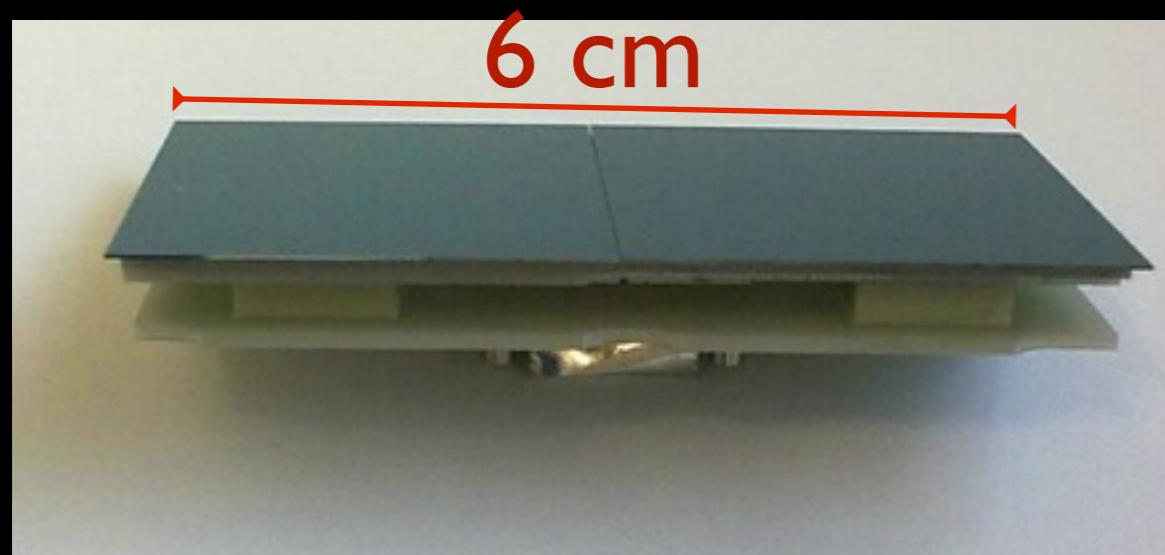
The ^{252}Cf source gives a “flat” spectrum of recoils at low energy. The shape of the measured spectrum in keVee gives the energy dependent quenching. Still some features to understand.

efficiency measurement using the neutrons from ^{252}Cf .



the experiment

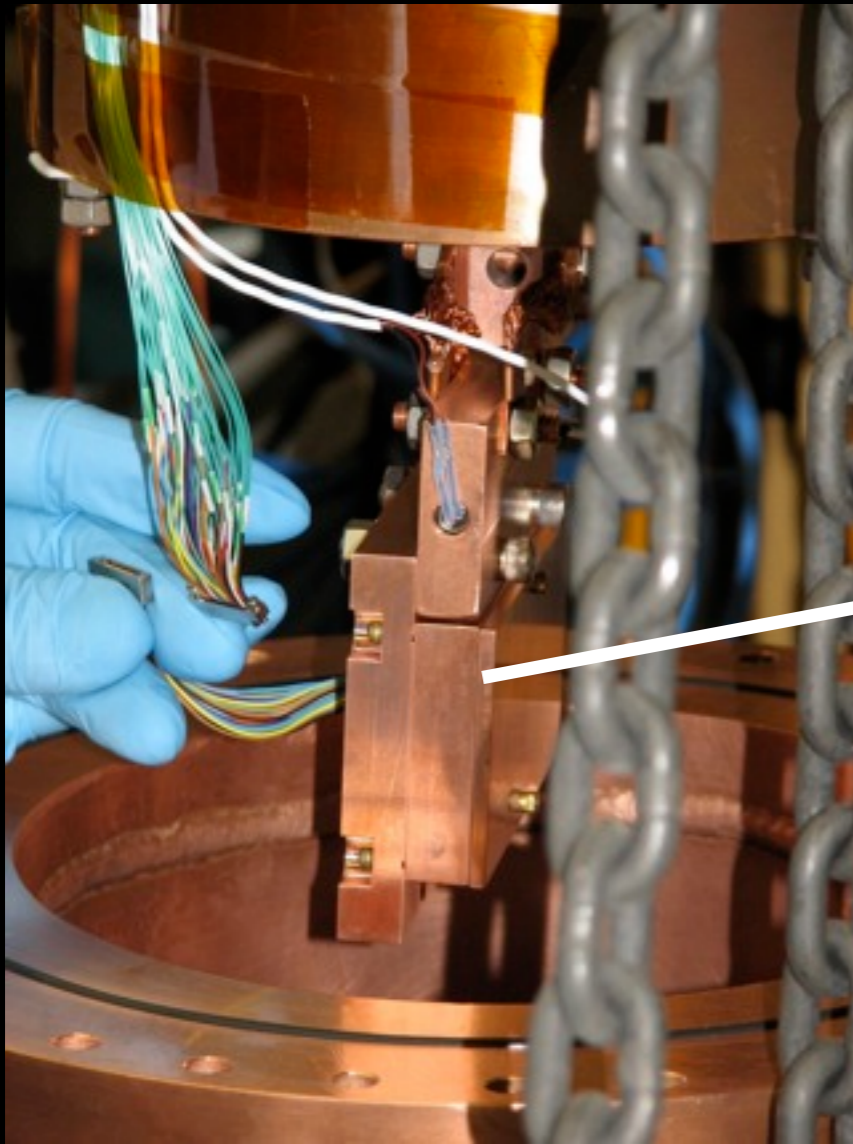
new CCD package using only AlN. The AlN was measured to be low background at during 2009.



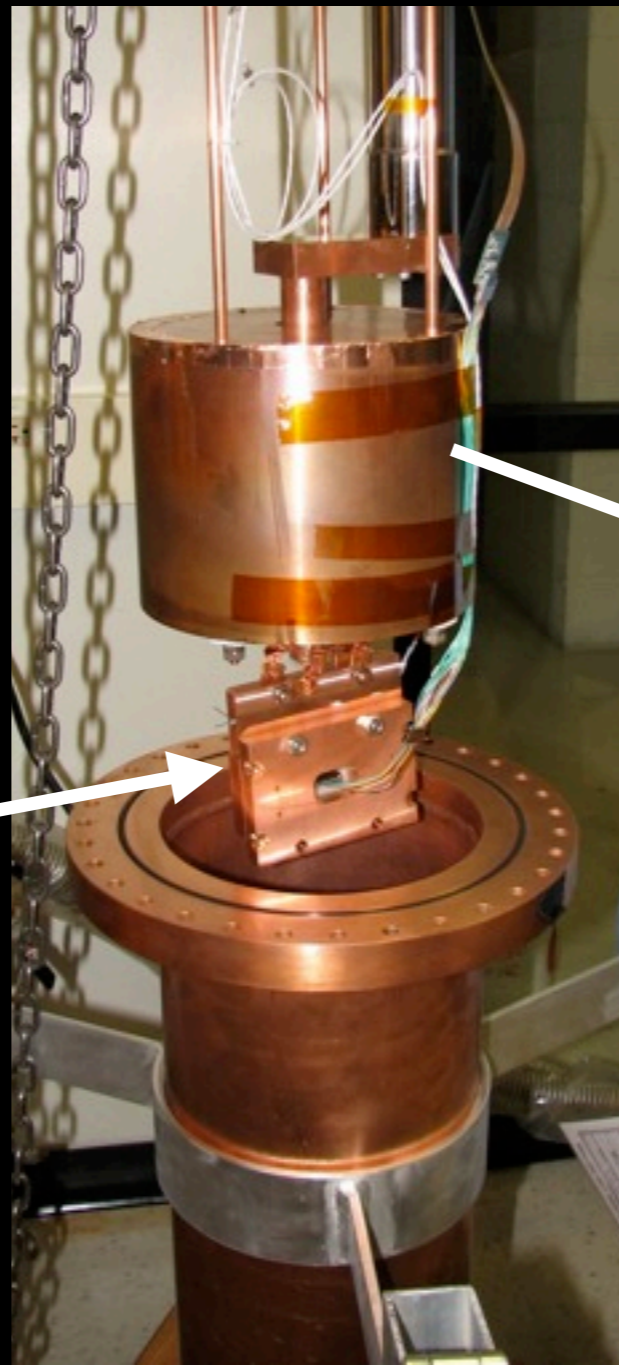
1 gram of Si



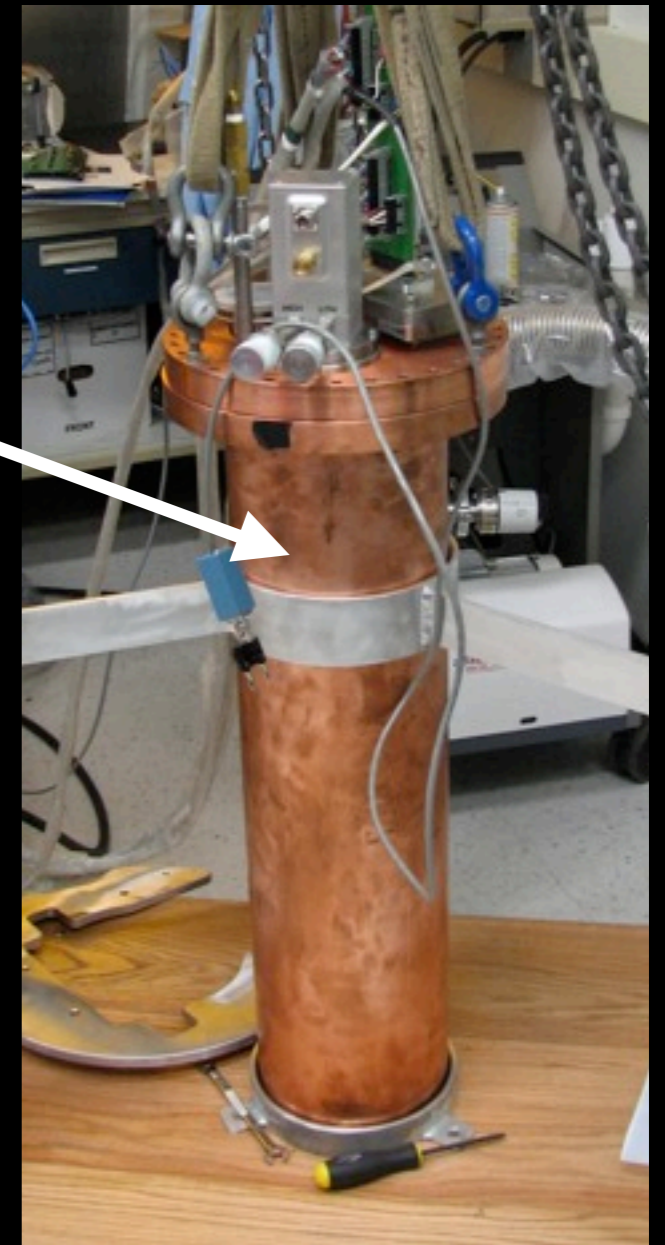
CCD wire-bonded to an AlN board. Some AlN blanks complete the package. Connector soldered to the back of the AlN board (connector radio purity unknown).



CCD inside a cold copper box. (IR shield)



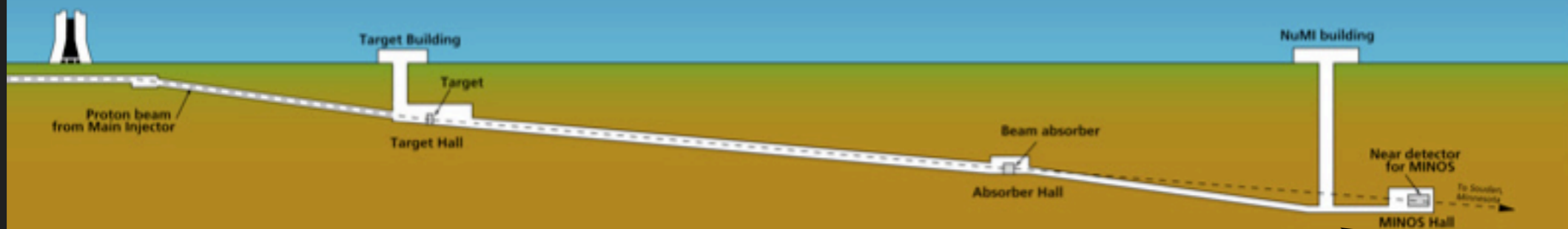
6" lead bucket inside vacuum



cylindrical copper dewar

DAMIC (FNAL T987)

Underground test of CCDs for DM

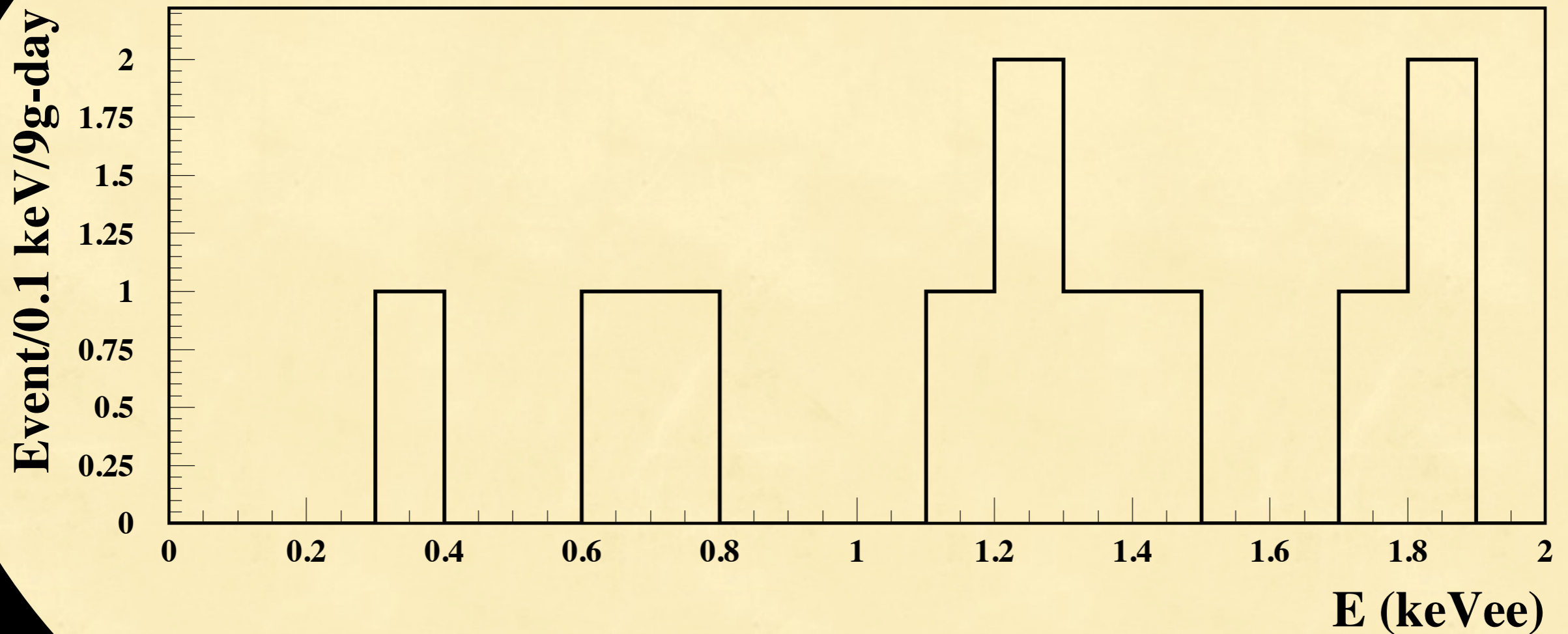


1 CCD

Installed on June 2010 350' underground at FNAL. This is the second version of DAMIC.

Preliminary
... just started running

Preliminary



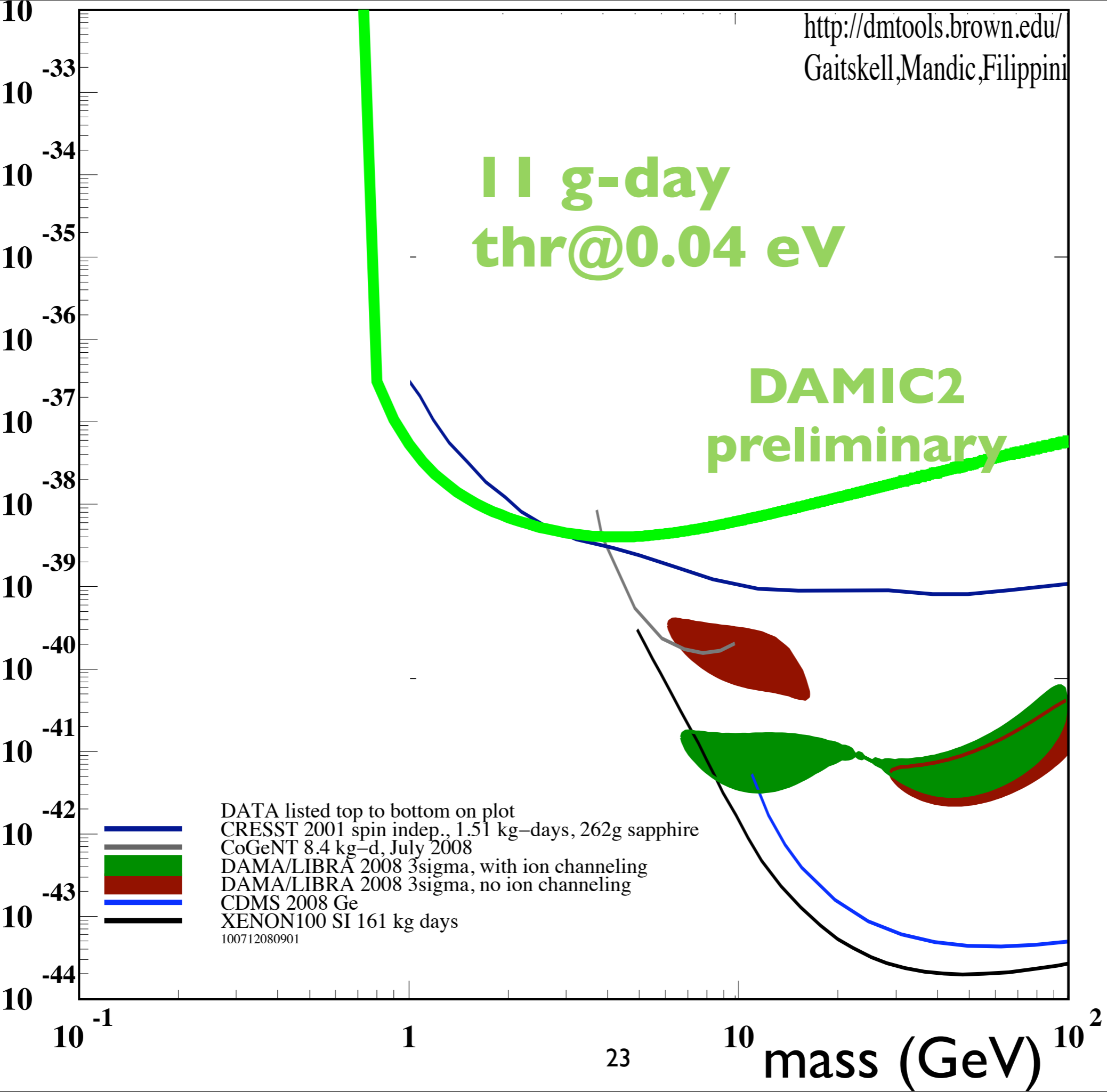
This is only after a couple of weeks running. Need to wait a bit longer to really measure the background spectrum. The expected limitation will be neutrons produced by muons in our shield. No muon veto!

cross section (cm²)

**11 g-day
thr@0.04 eV**

**DAMIC2
preliminary**

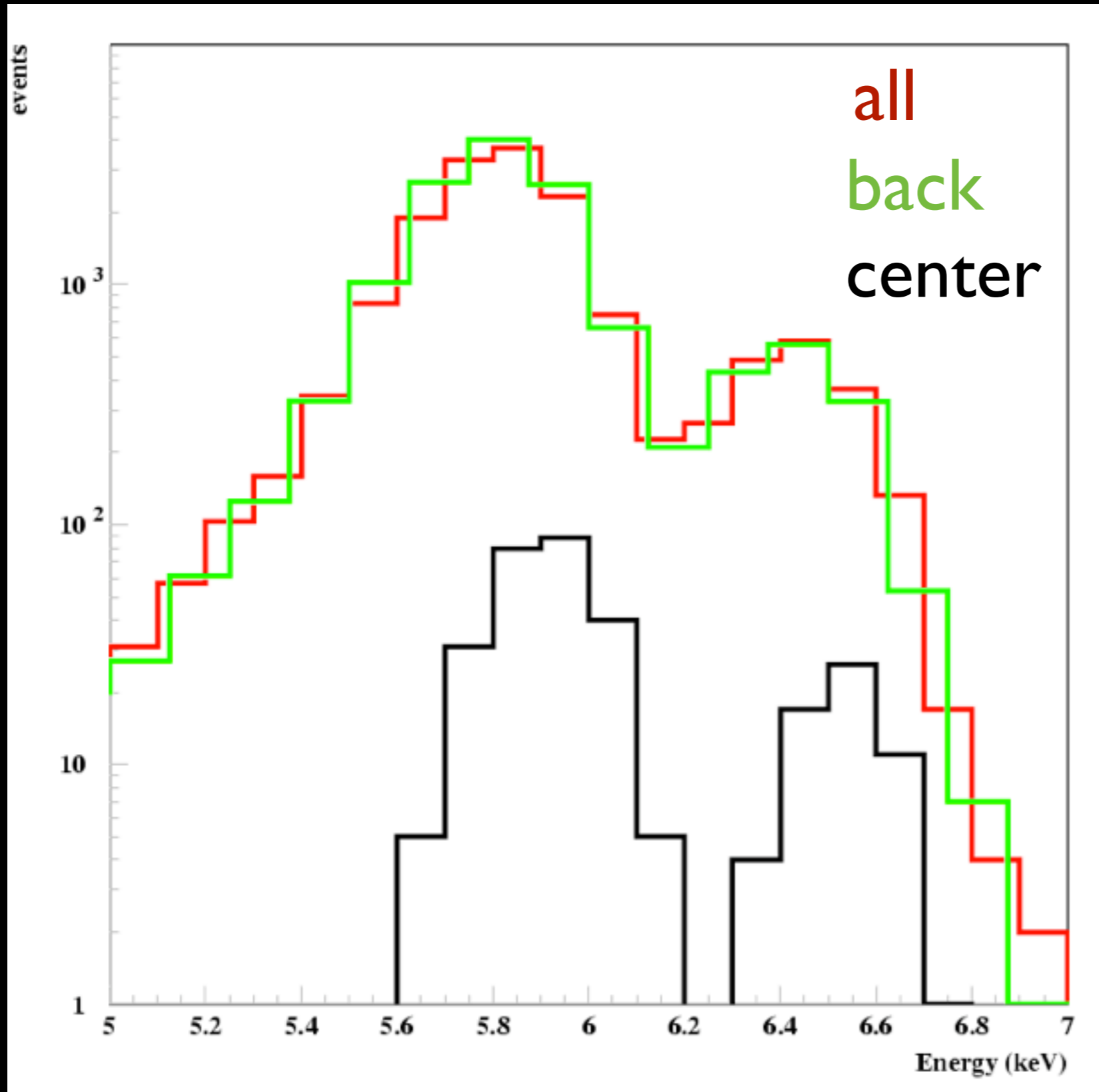
- DATA listed top to bottom on plot
 - CRESST 2001 spin indep., 1.51 kg-days, 262g sapphire
 - CoGeNT 8.4 kg-d, July 2008
 - DAMA/LIBRA 2008 3sigma, with ion channeling
 - DAMA/LIBRA 2008 3sigma, no ion channeling
 - CDMS 2008 Ge
 - XENON100 SI 161 kg days
- 100712080901



Conclusion

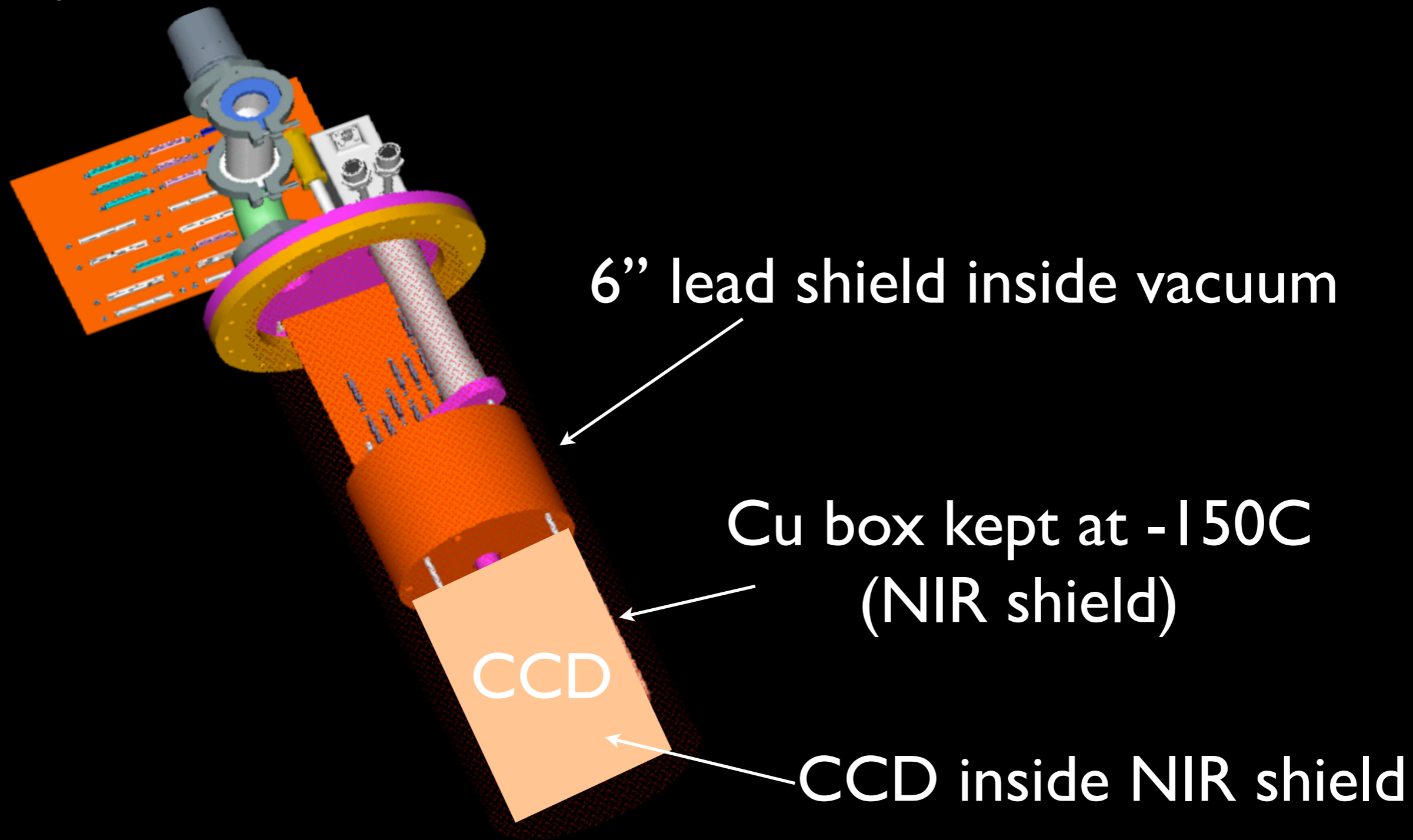
- DAMIC is now competitive searching for DM particles with masses ~ 1 GeV.
- Low threshold of 0.040 keV makes this possible.
- Future is promising :
 - new readout system to reduce noise by x2
 - 10g detector possible during 2010
 - go deeper to reduce muons 2011
- Stay tuned for exciting DAMIC results

back illumination with x-rays

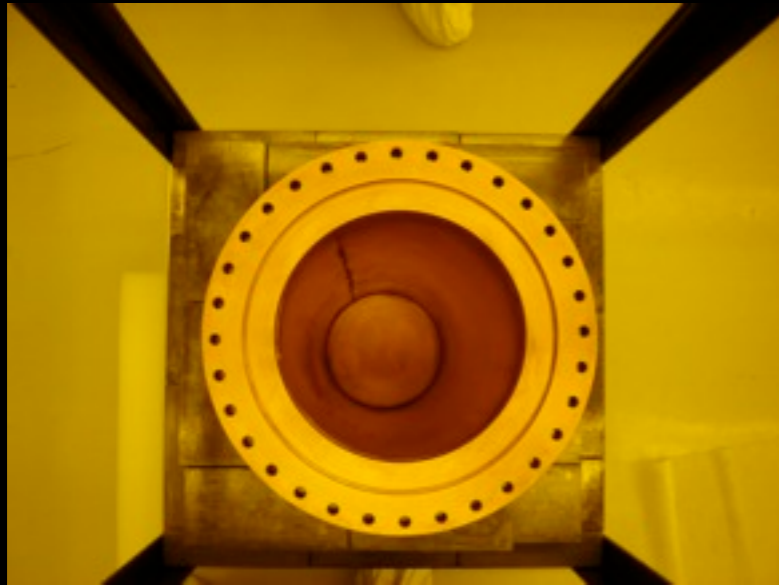


selection cut
gives a factor
20 rejection
for X-rays.

2010



test fit



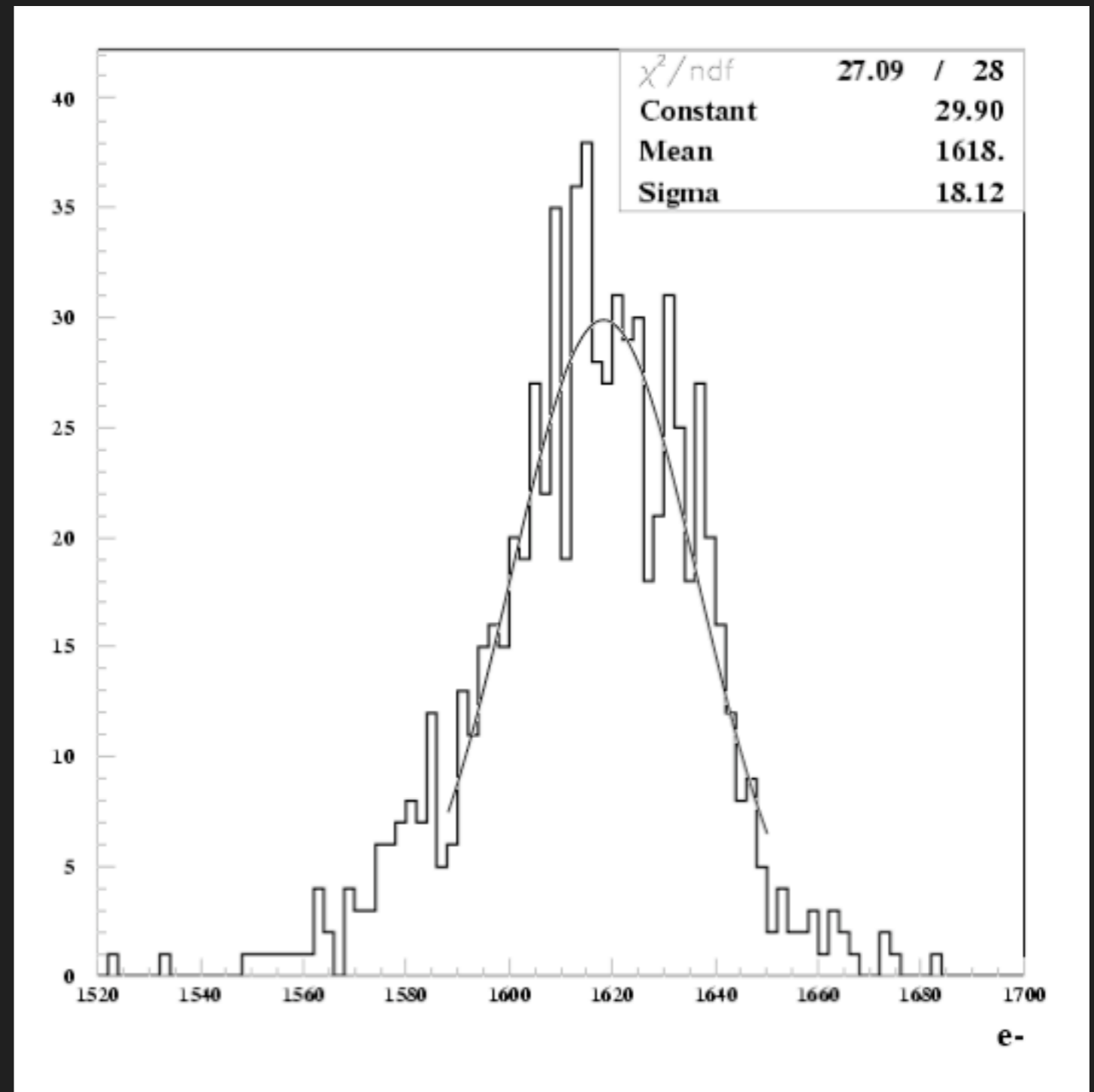
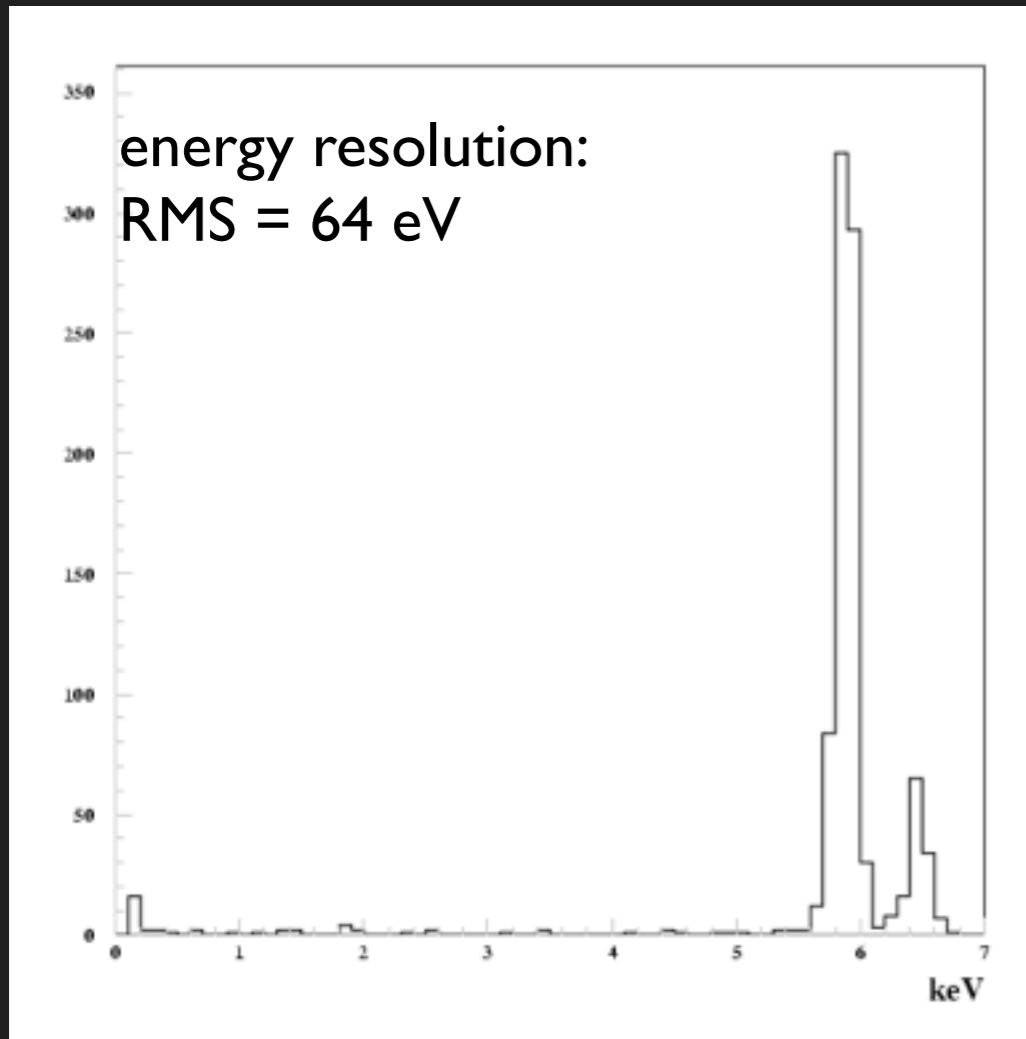
underground installation



vacuum
vessel inside
a 6" lead
shield



low noise readout for Fe55



effective fano factor:

$$F_{\text{eff}} = (18^2 - 2^2) / 1620.$$

$$F_{\text{eff}} = 0.17$$

this typical for CCDs

(CTI, clustering)

in silicon: 0.10

DAMIC (FNAL T987)

Underground test of CCDs for DM

2009

CPA people:

DES: T. Diehl, J. Estrada, B. Flaughter, , D. Kubik, V. Scarpine

COUPP: E. Ramberg, A. Sonnenschein

CDF: Ben Kilminster

Visitors:

J. Molina (CIEMAT), J. Jones (Purdue)

Engineering (mostly DECam people and spares when available)

Mech: H.Cease, K. Schultz

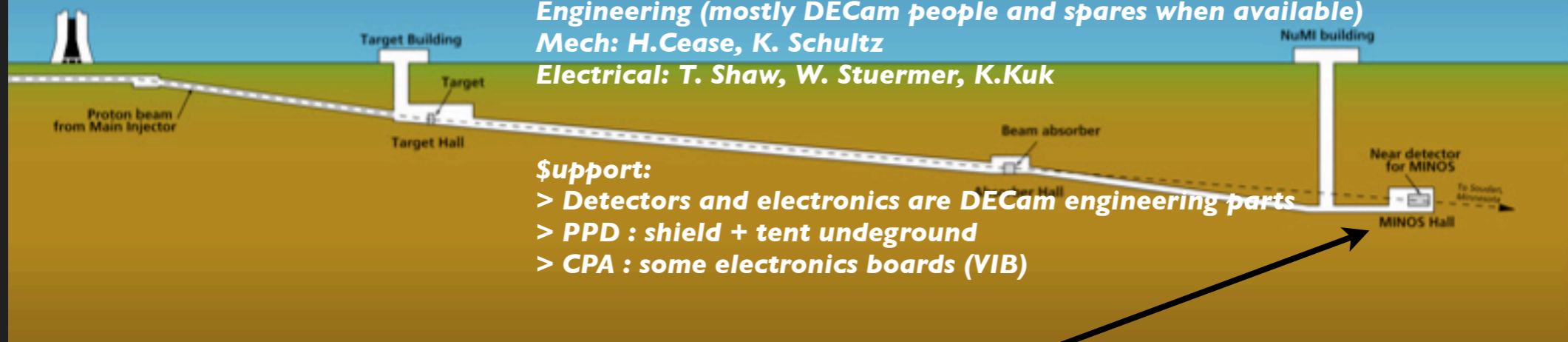
Electrical: T. Shaw, W. Stuermer, K.Kuk

\$upport:

> Detectors and electronics are DECam engineering parts

> PPD : shield + tent underground

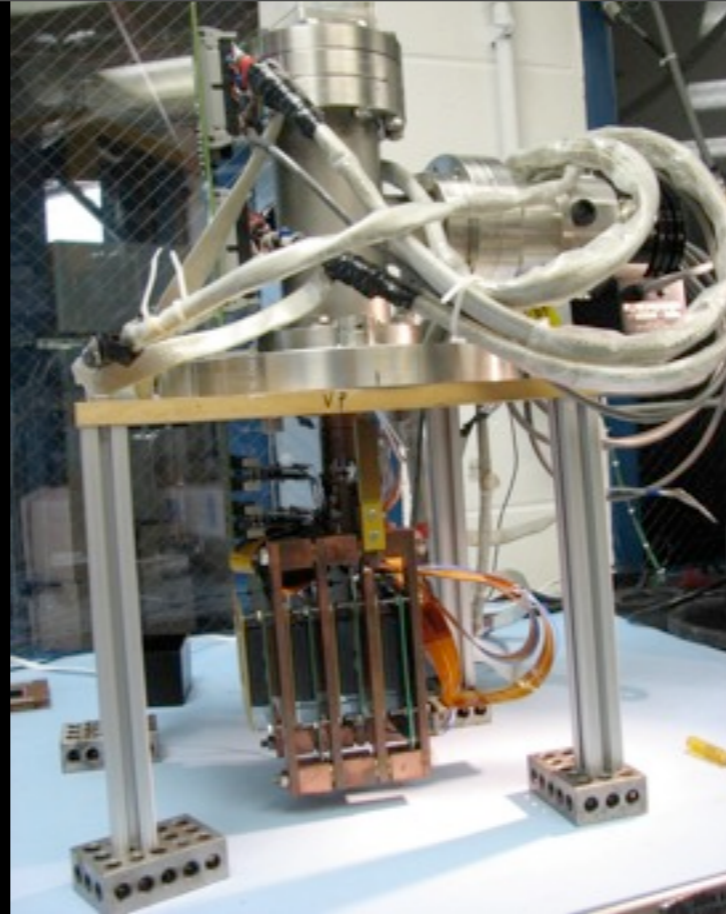
> CPA : some electronics boards (VIB)



setting up a 4CCD array here. ~350 foot depth



2009

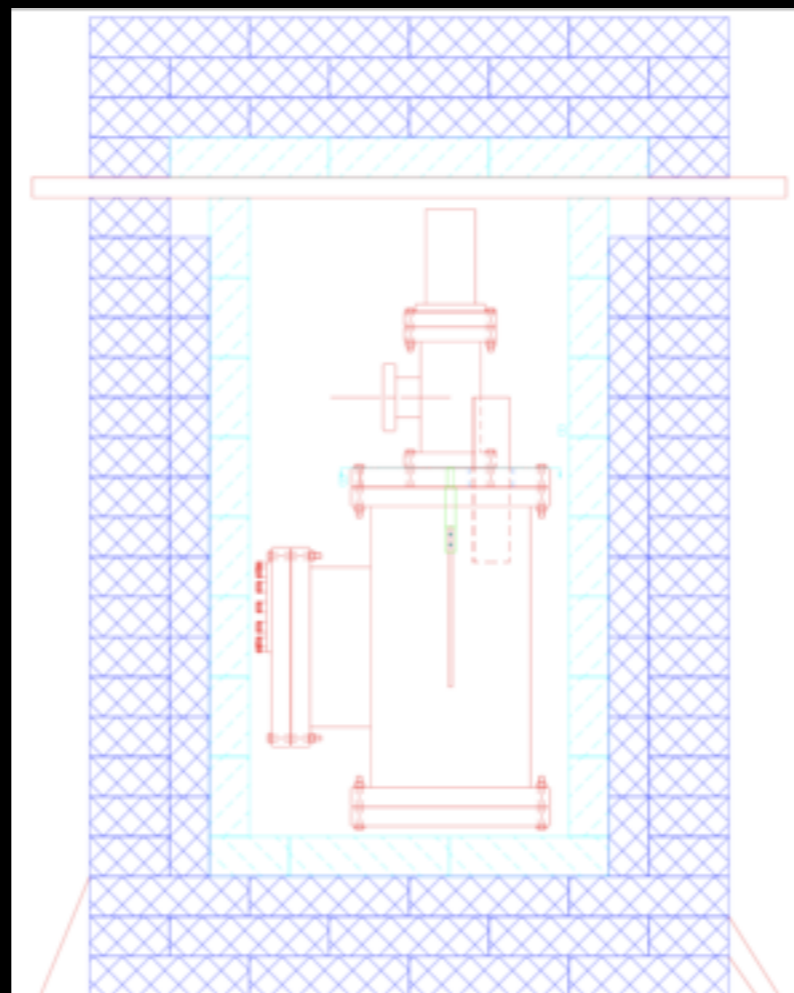


- 4 CCDs in picture frame packages (detector testing package with electronics very close to it)
- cryocooler + pump port + ion gauge inside the lead shield.
- stainless steel dewar

results:

~3000 cpd/keV

IR radiation from dewar wall dominating low energy background.



why 10^3 cpd/kg/day at 1 keV:

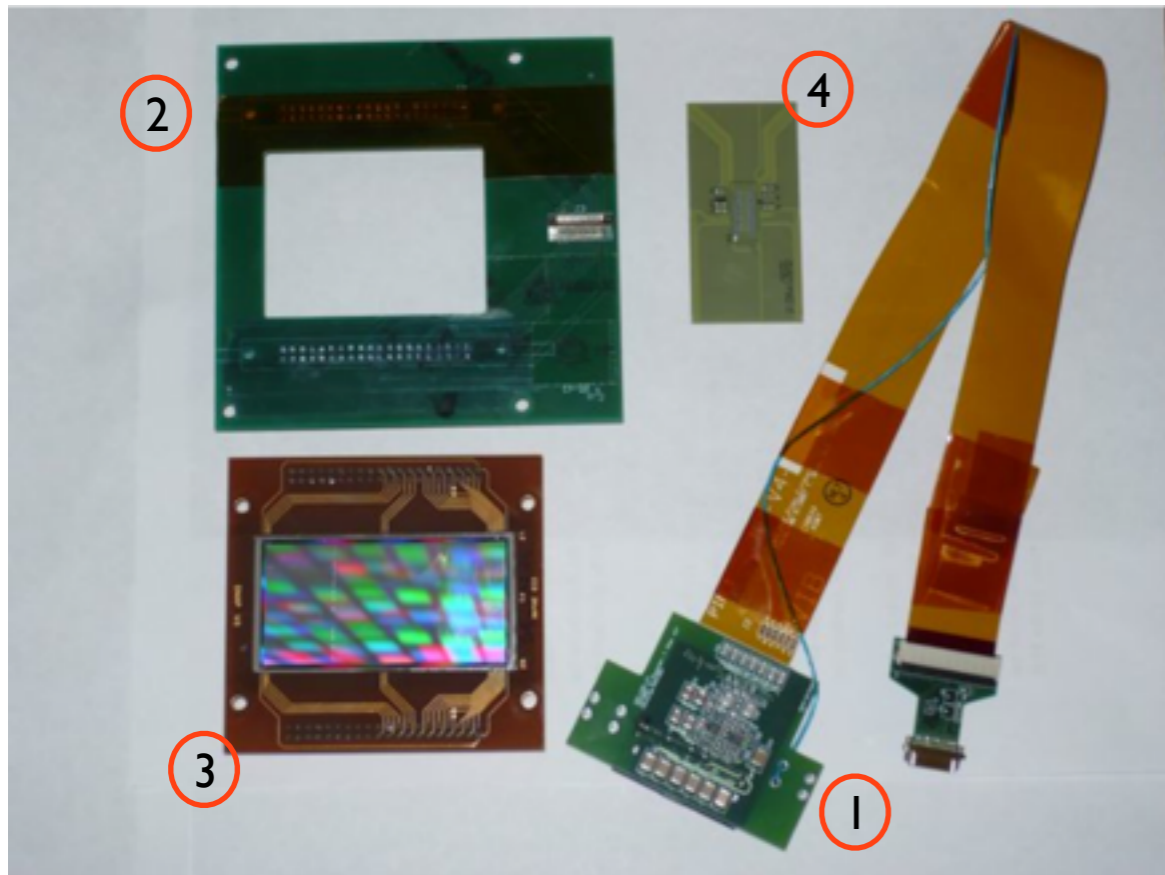


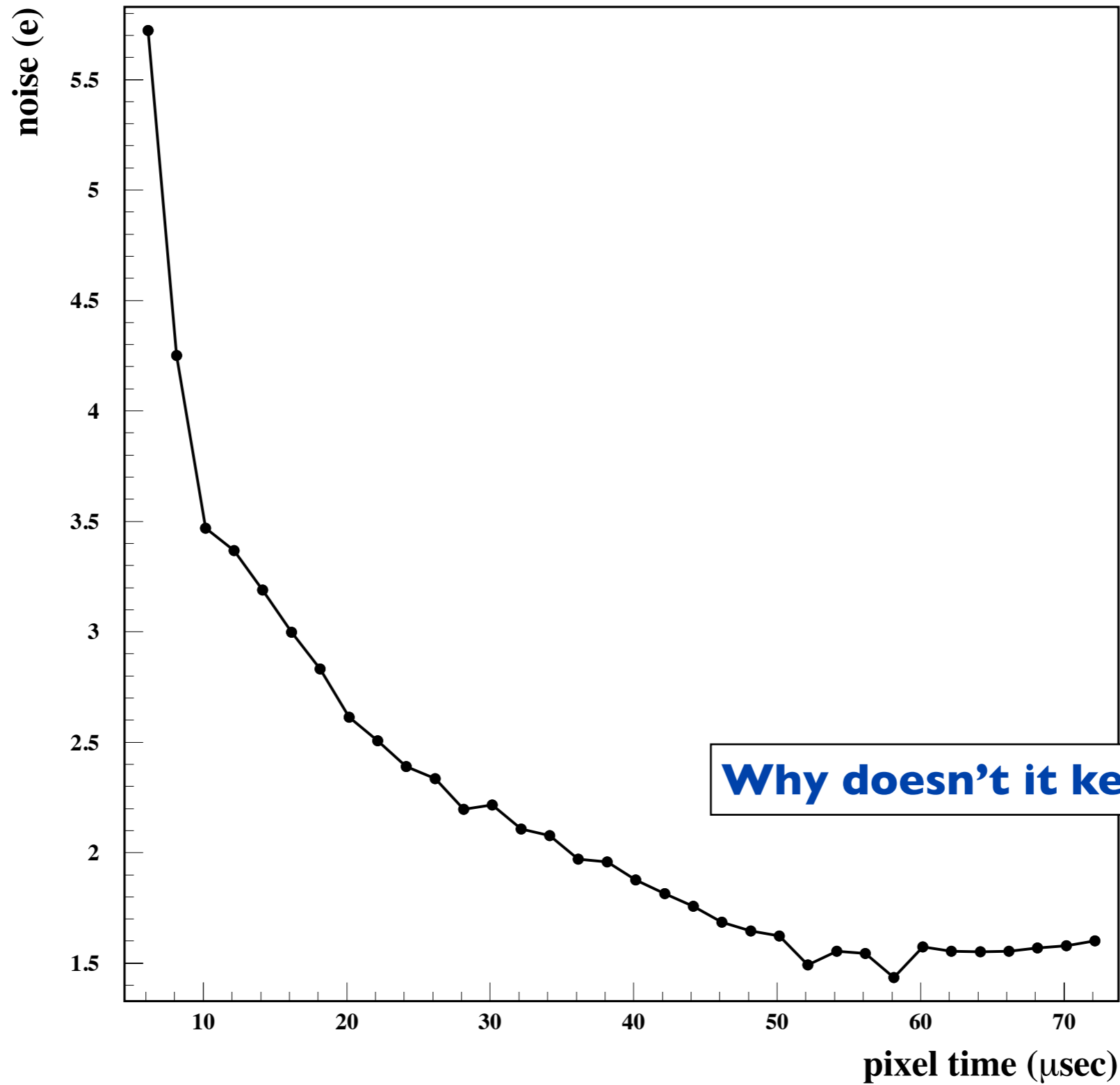
TABLE I: Radioactive decay measurement

Detector part	Sample mass	Material	Activity
① Kapton cables 9 pieces	218 gr	^{238}U	0.88 ppm
		^{232}Th	1.70 ppm
		^{40}K	0.012 pct
② Picture frame adapters 15 pieces	476 gr	^{238}U	0.99 ppm
		^{232}Th	3.76 ppm
		^{40}K	0.027 pct
③ Picture frame 16 pieces	256 gr	^{238}U	1.18 ppm
		^{232}Th	5.59 ppm
		^{40}K	0.031 pct
④ Aluminum nitride 10 pieces	105.6 gr	all	< 1 ppm

measurements done at LBNL.

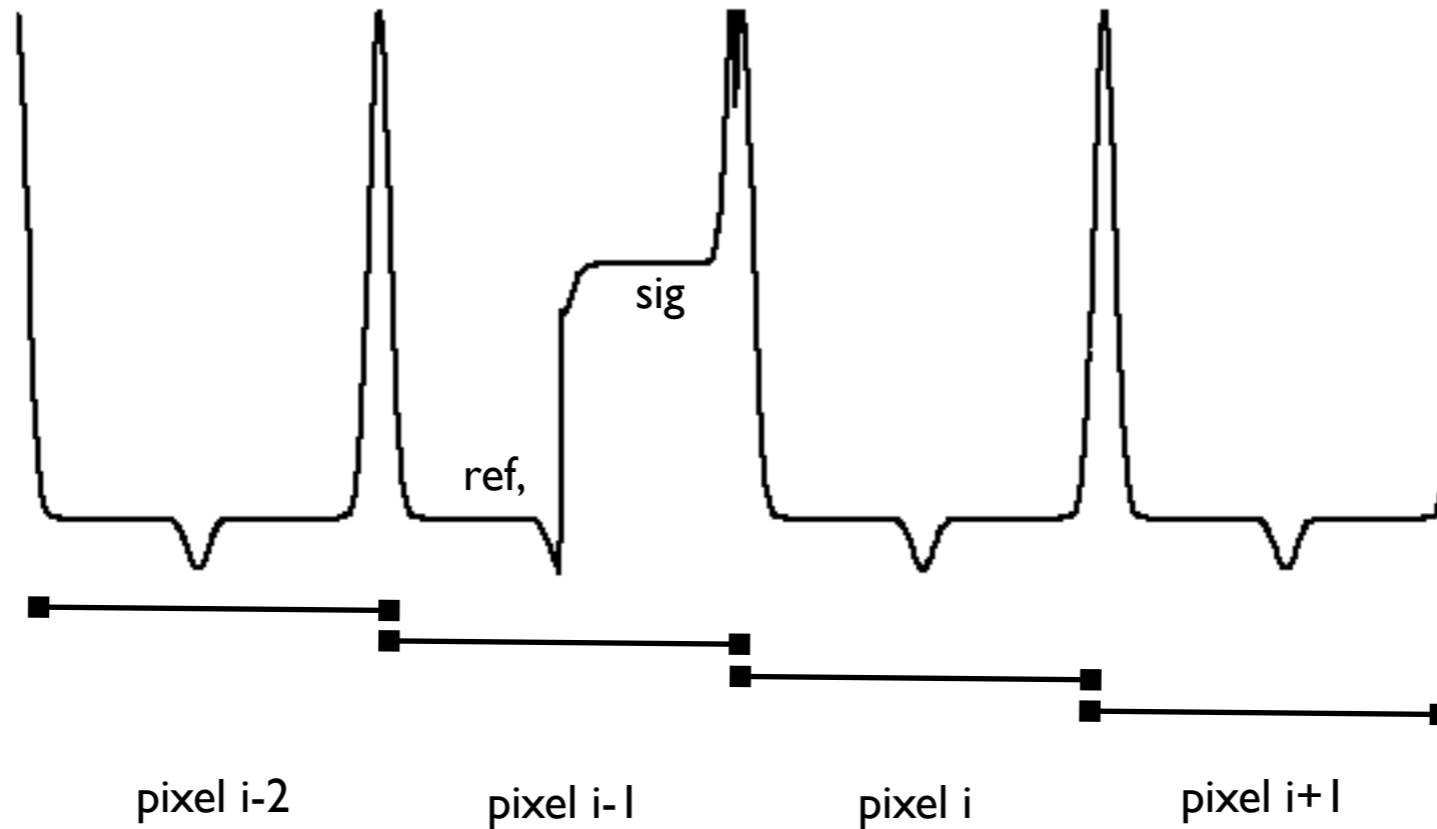
we need a new packaging and electronics. We are eliminating kapton cable in the next version.

Plan to reduce the readout noise



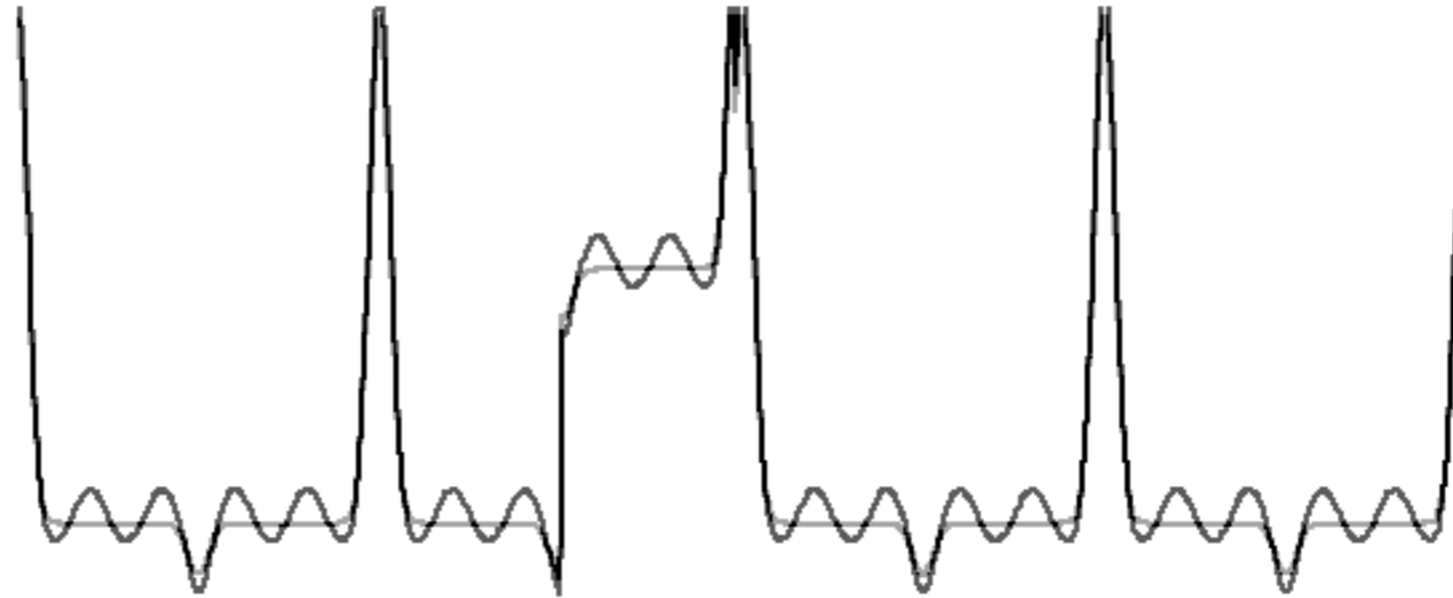
Why doesn't it keep going down?

Correlated Double Sampling readout (CDS)

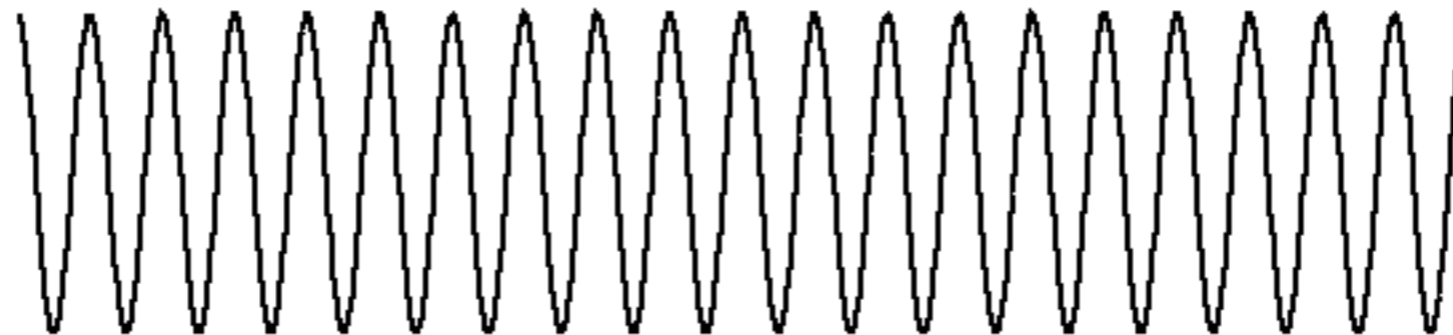


$$s_j^{c ds} = \int_{t_j + \epsilon}^{t_j + \delta + \epsilon} [n(t) + \hat{s}_j] dt - \int_{t_j}^{t_j + \delta} n(t) dt.$$

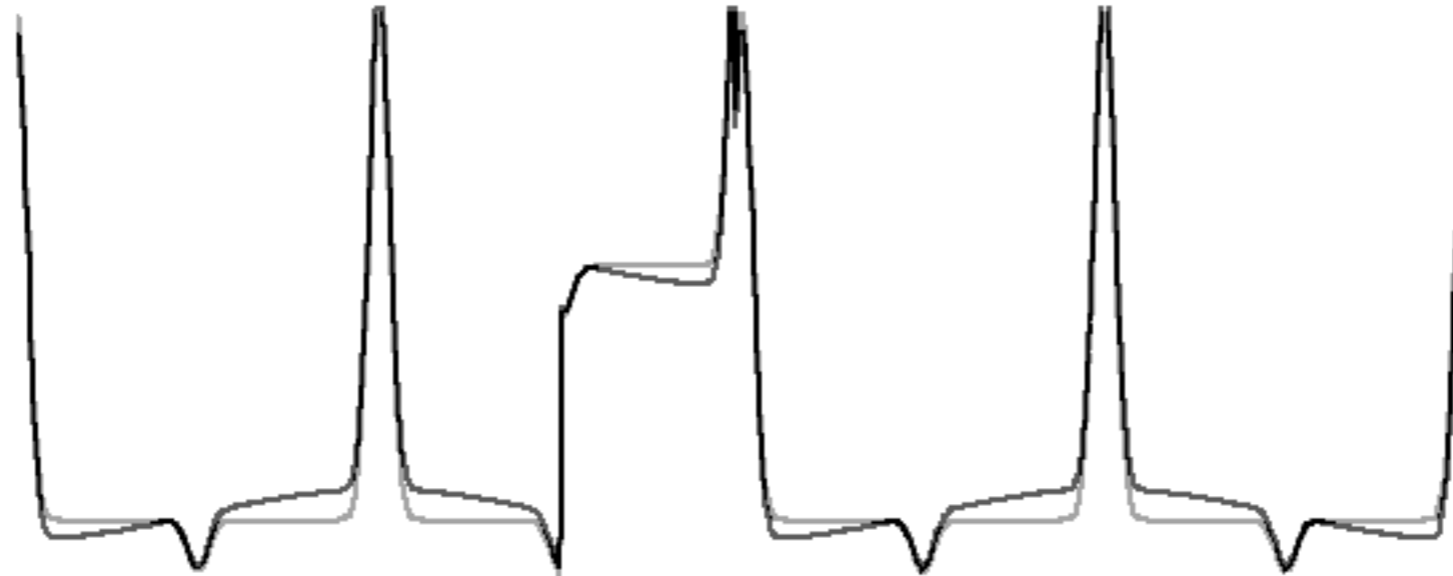
filtering of high frequencies is responsible for reduction with integration time



this “high frequency” noise is efficiently suppressed by the integrations for each window in the correlated double sampling.



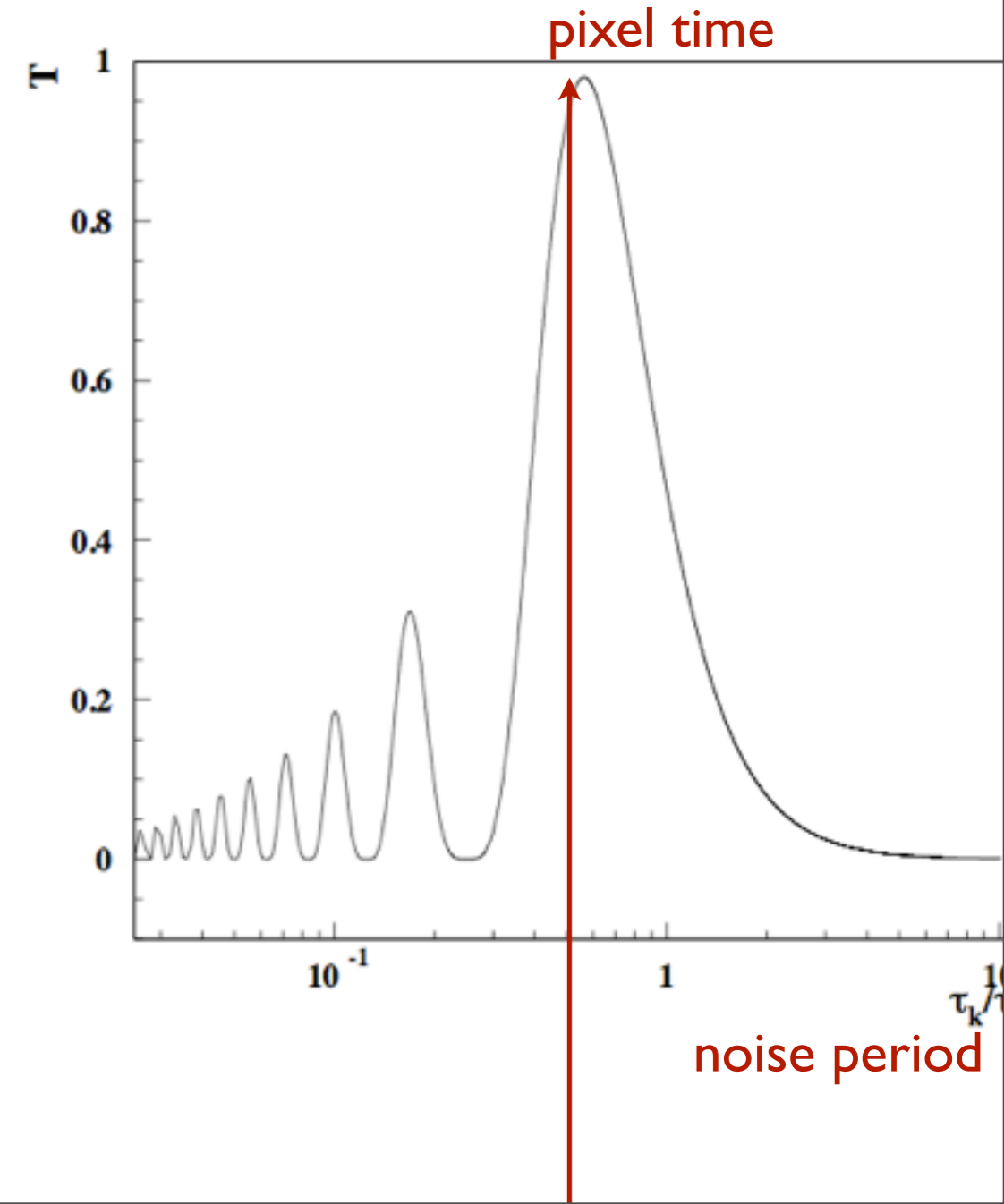
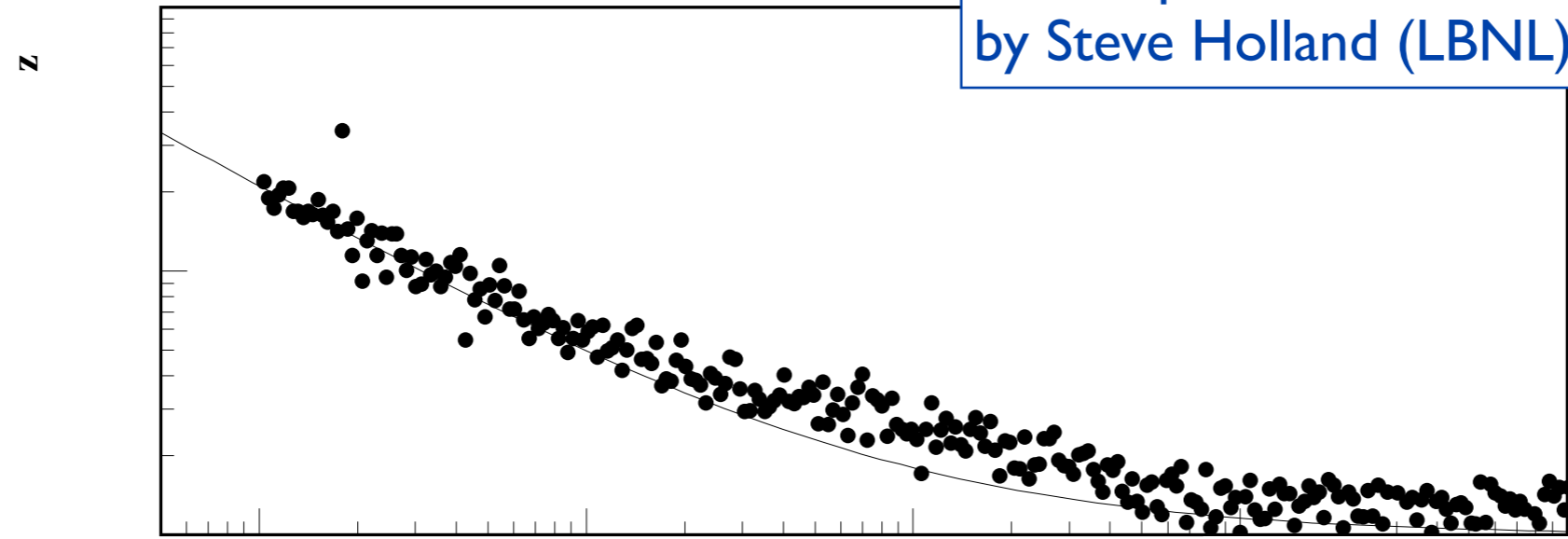
noise at pixel frequency is not suppressed by CDS



the noise with frequency of the order of the pixel is not filtered by the CDS. The only way to measure this contribution well is to look for the coherence of the noise over many pixels.

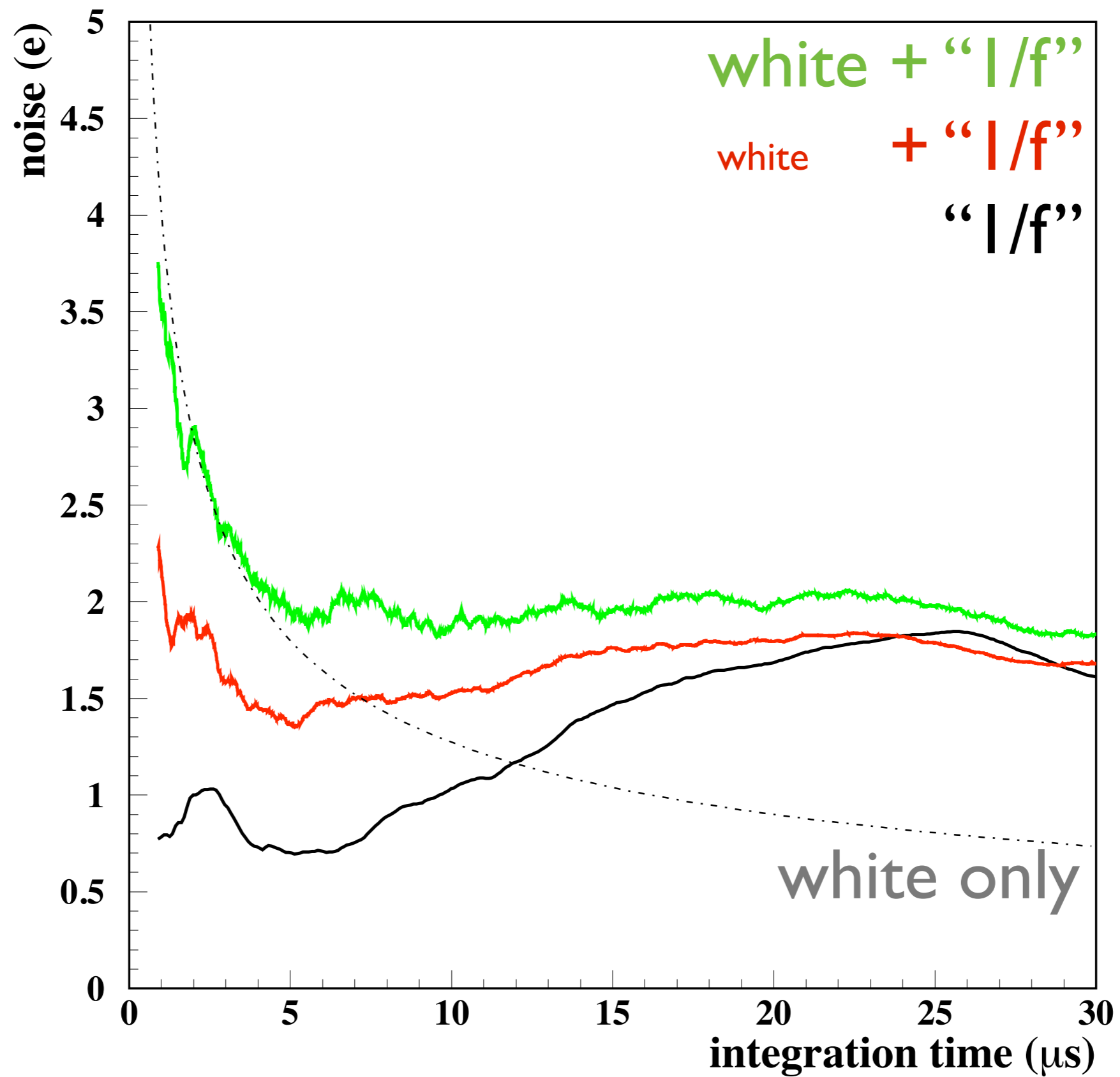


Noise spectrum for the CCD output provided by Steve Holland (LBNL).

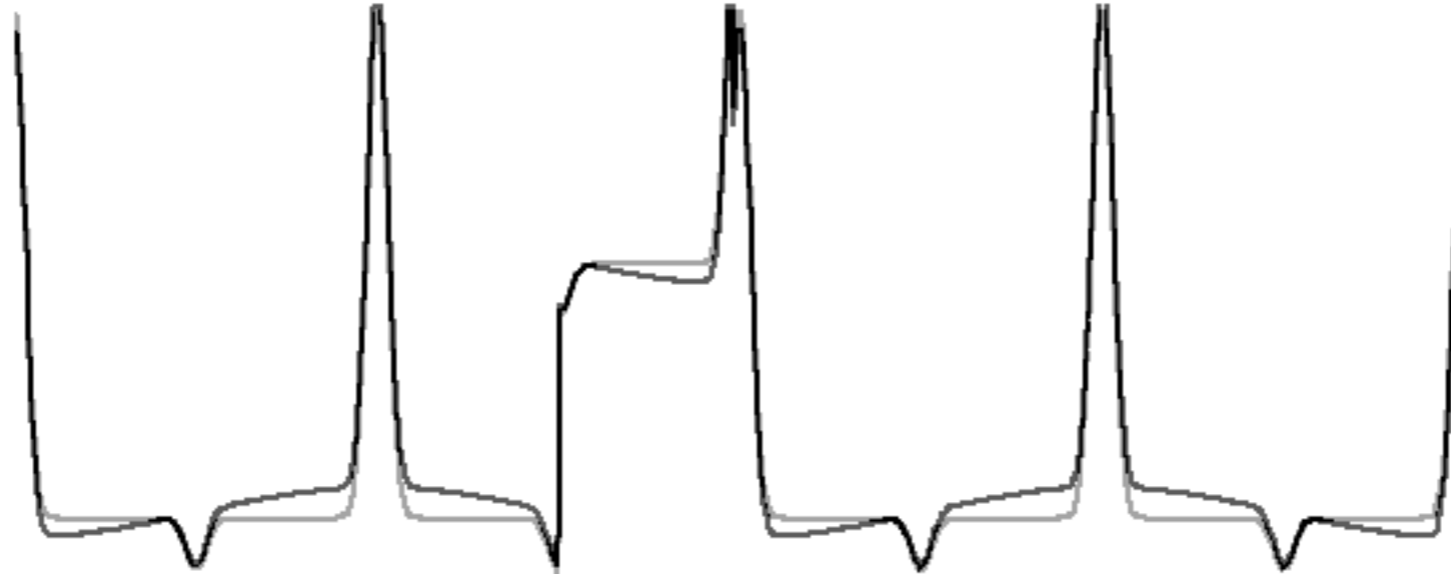


For long pixel times, CDS becomes susceptible to lower frequencies. Since there is a “1/f” aspect of to the noise, the CDS noise goes up when you make the pixel longer.

CDS noise in CCD simulation



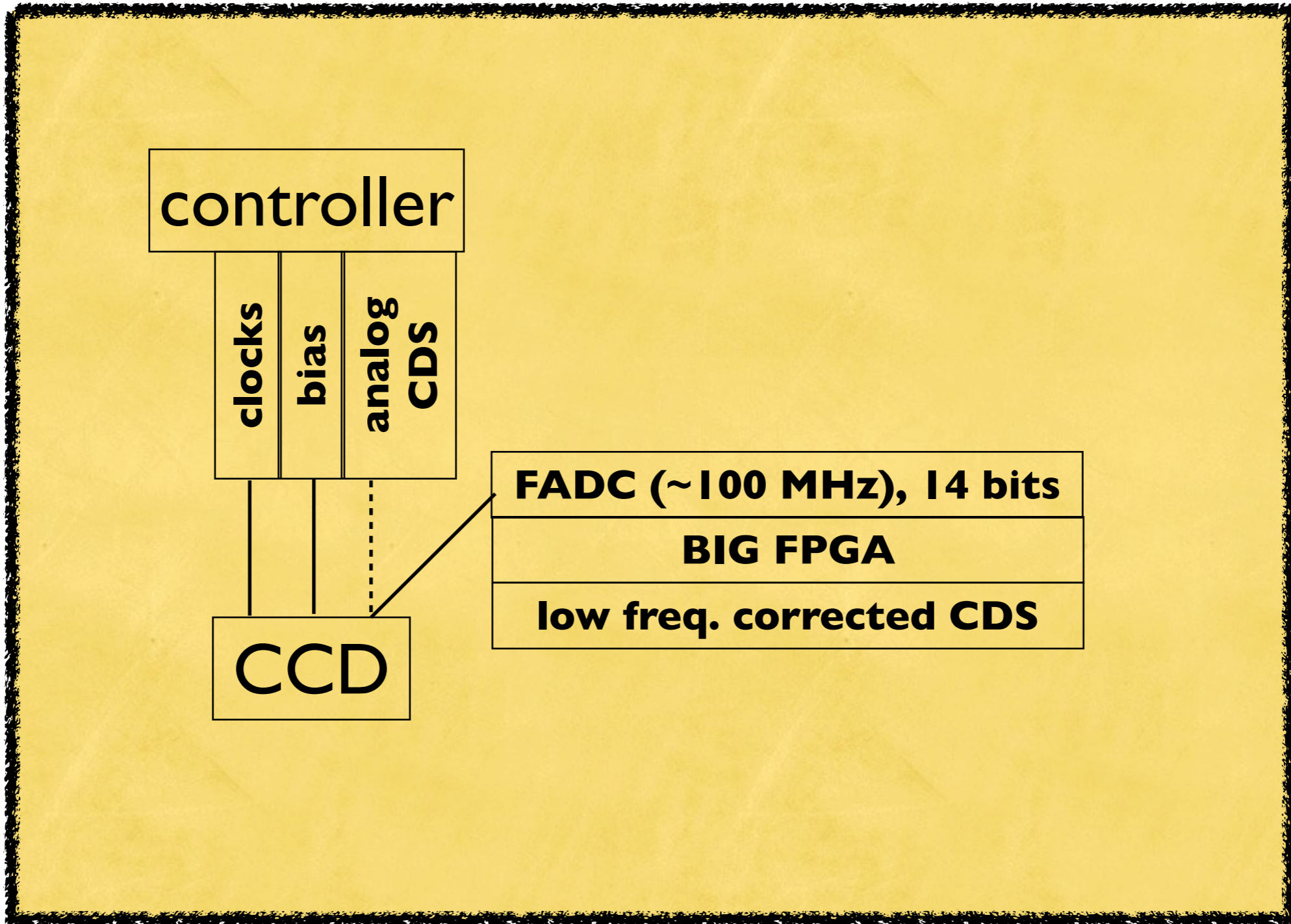
our strategy



sample the video signal of the CCD over many pixels with a fast ADC, then fit low low frequency components and subtract then before doing the CDS. This should suppress the low frequency noise contribution to CDS.

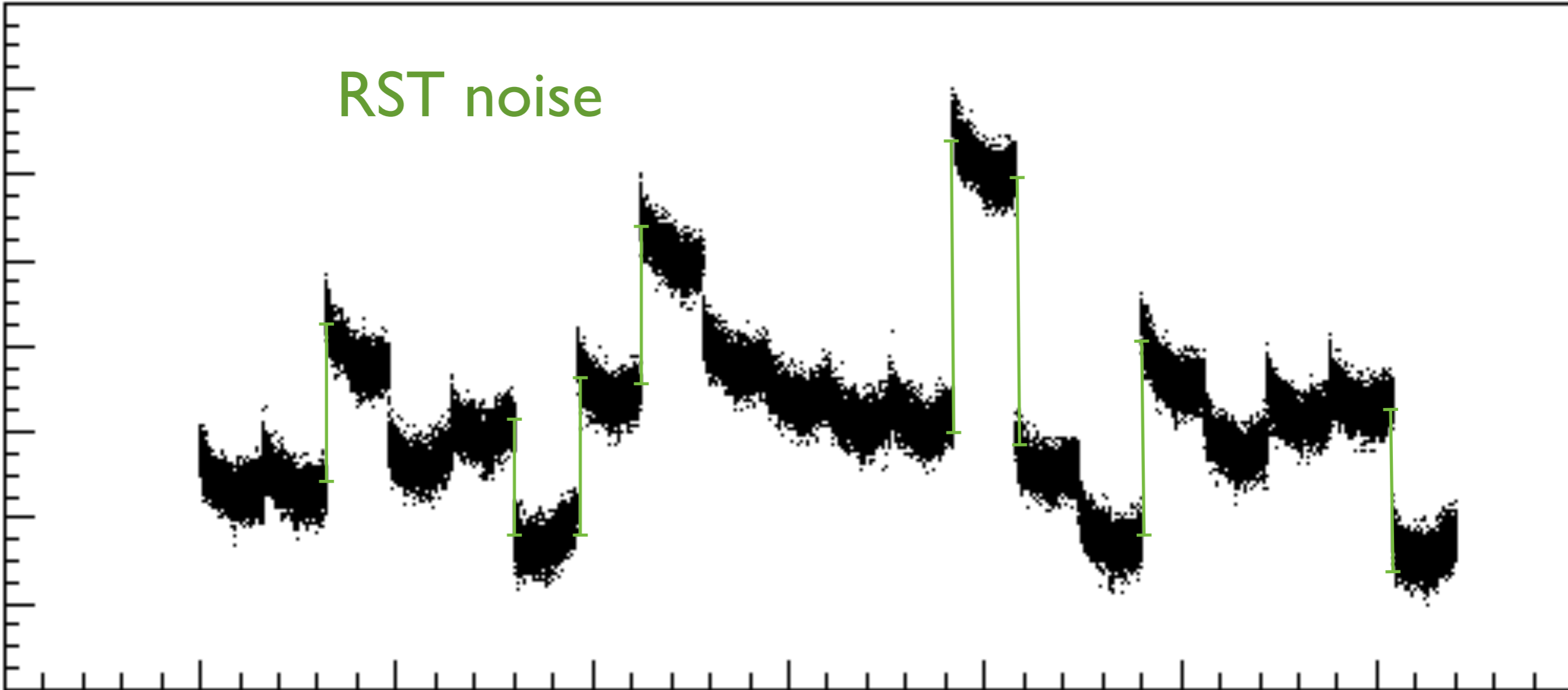


our strategy

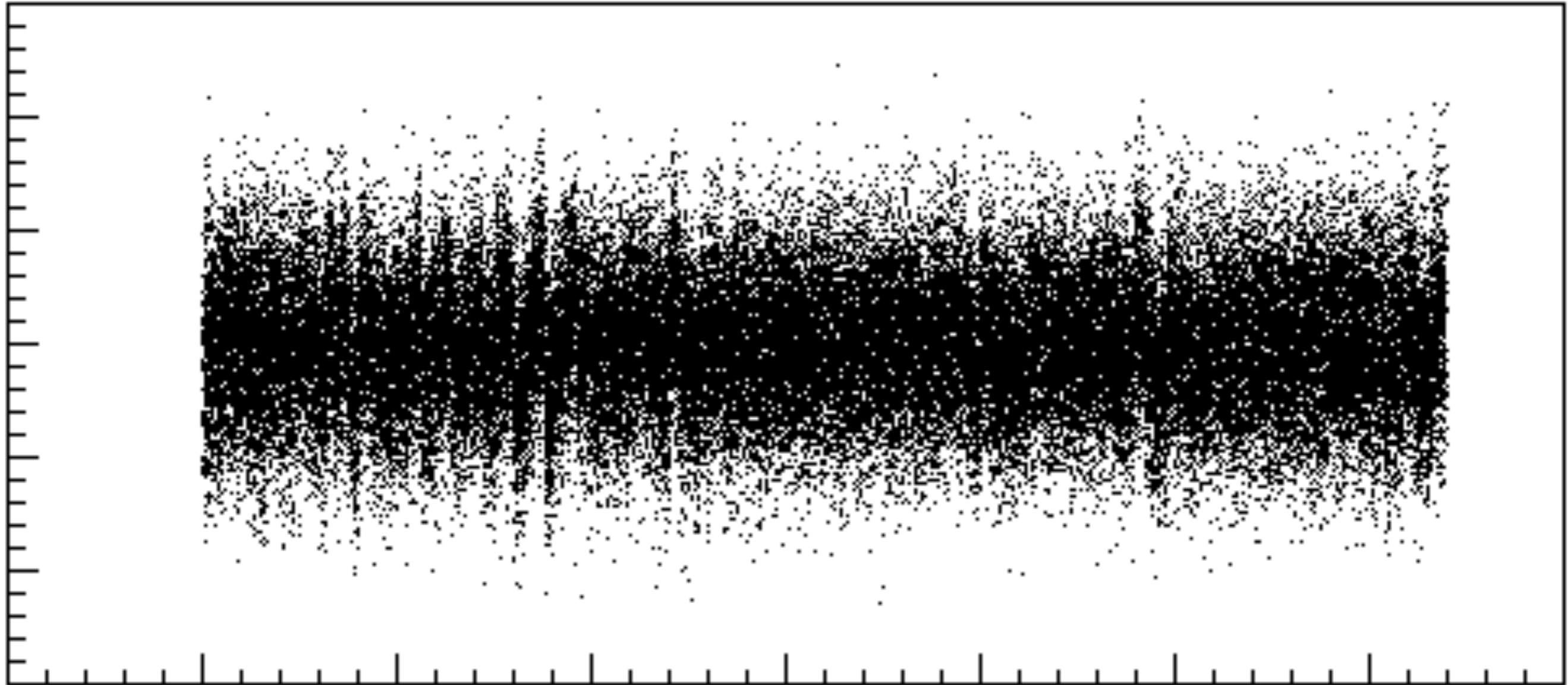


Step I: Digitize the signal

RST noise

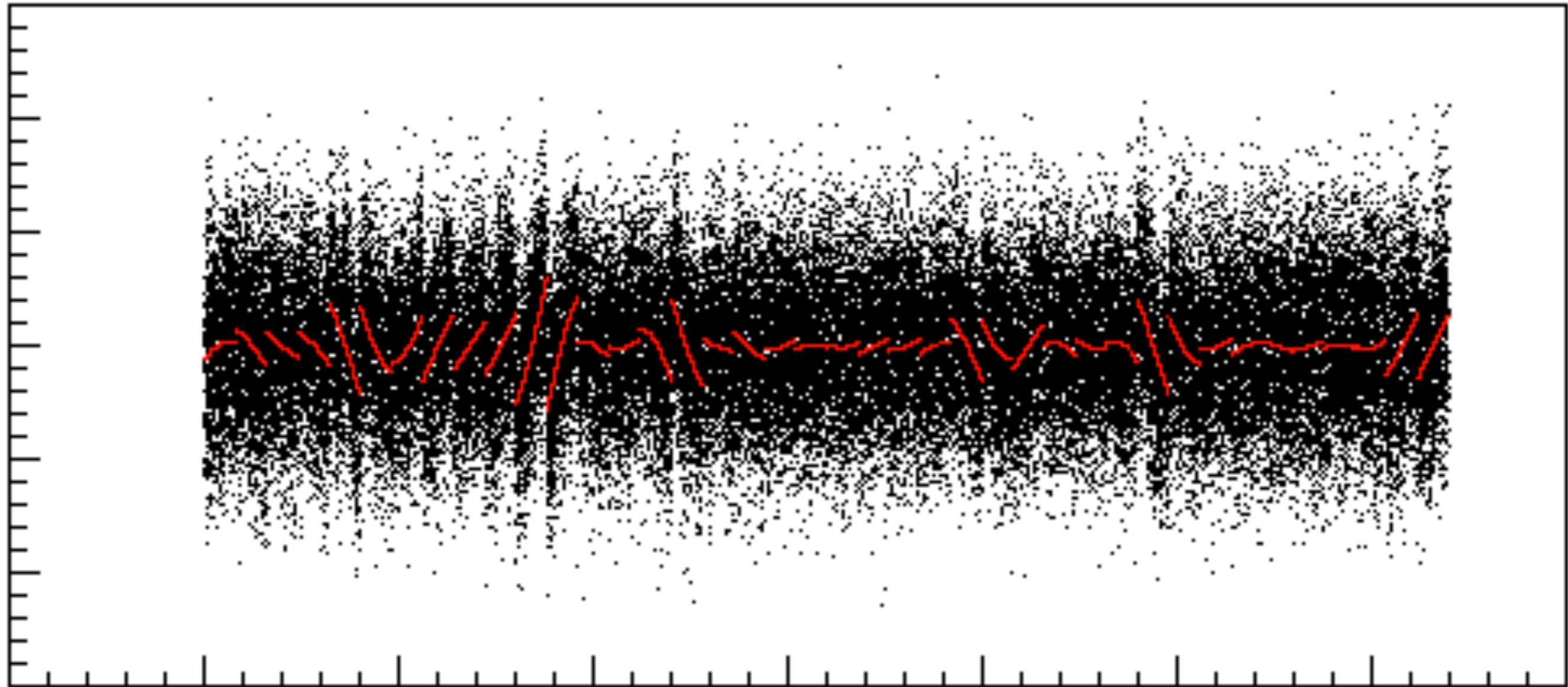


Step 2: remove features
(RST noise, signal level, clocks, pixel average shape)

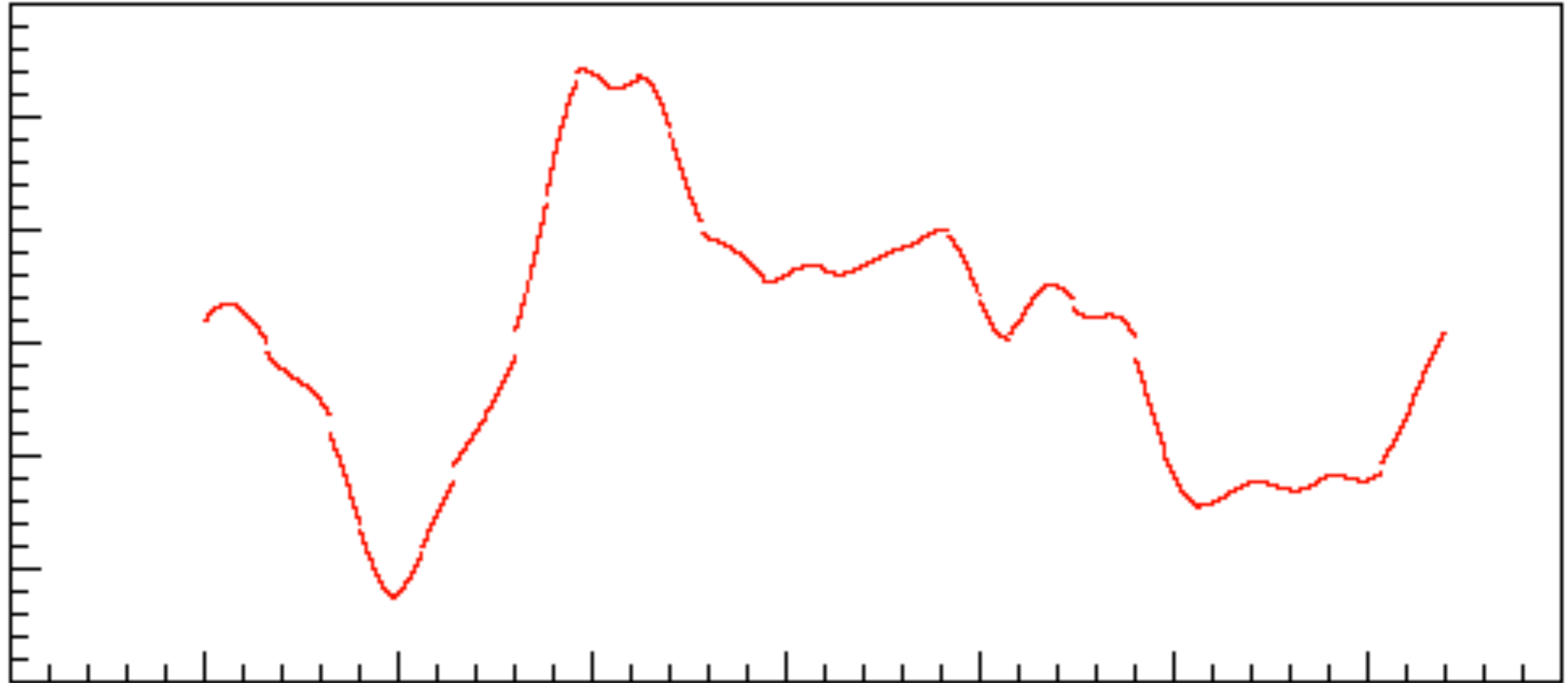


can you see the low frequency coherent components?

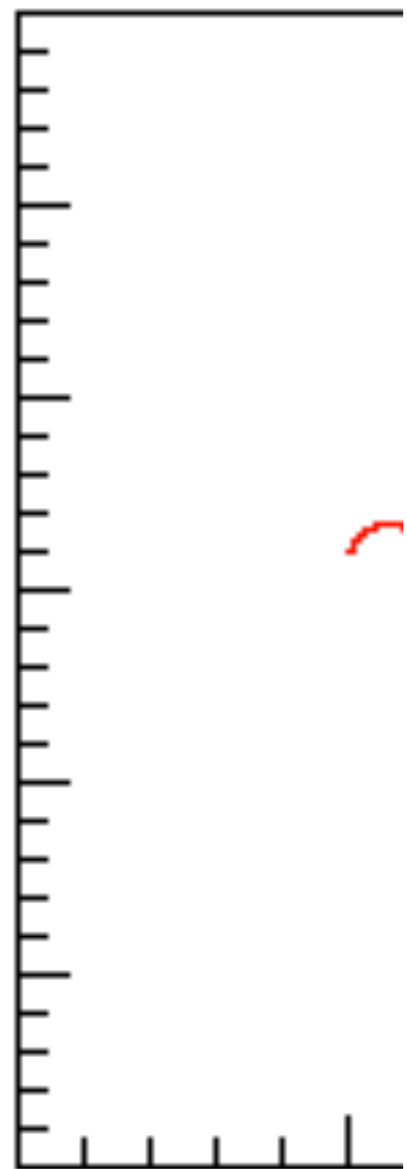
Step 3: Fit the low frequency noise (allow for jumps!)



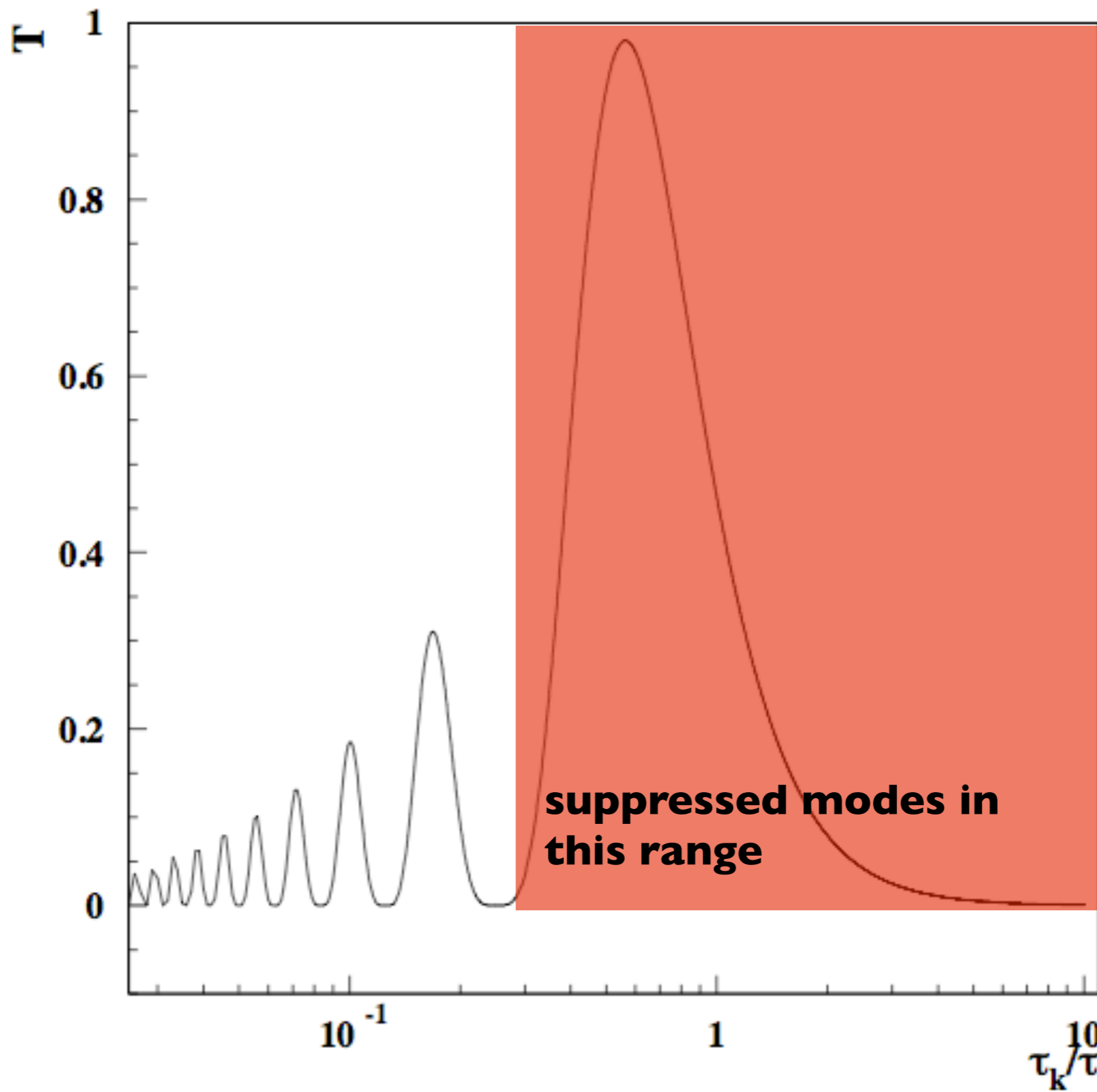
this is the difficult part... solve a very large χ^2 problem



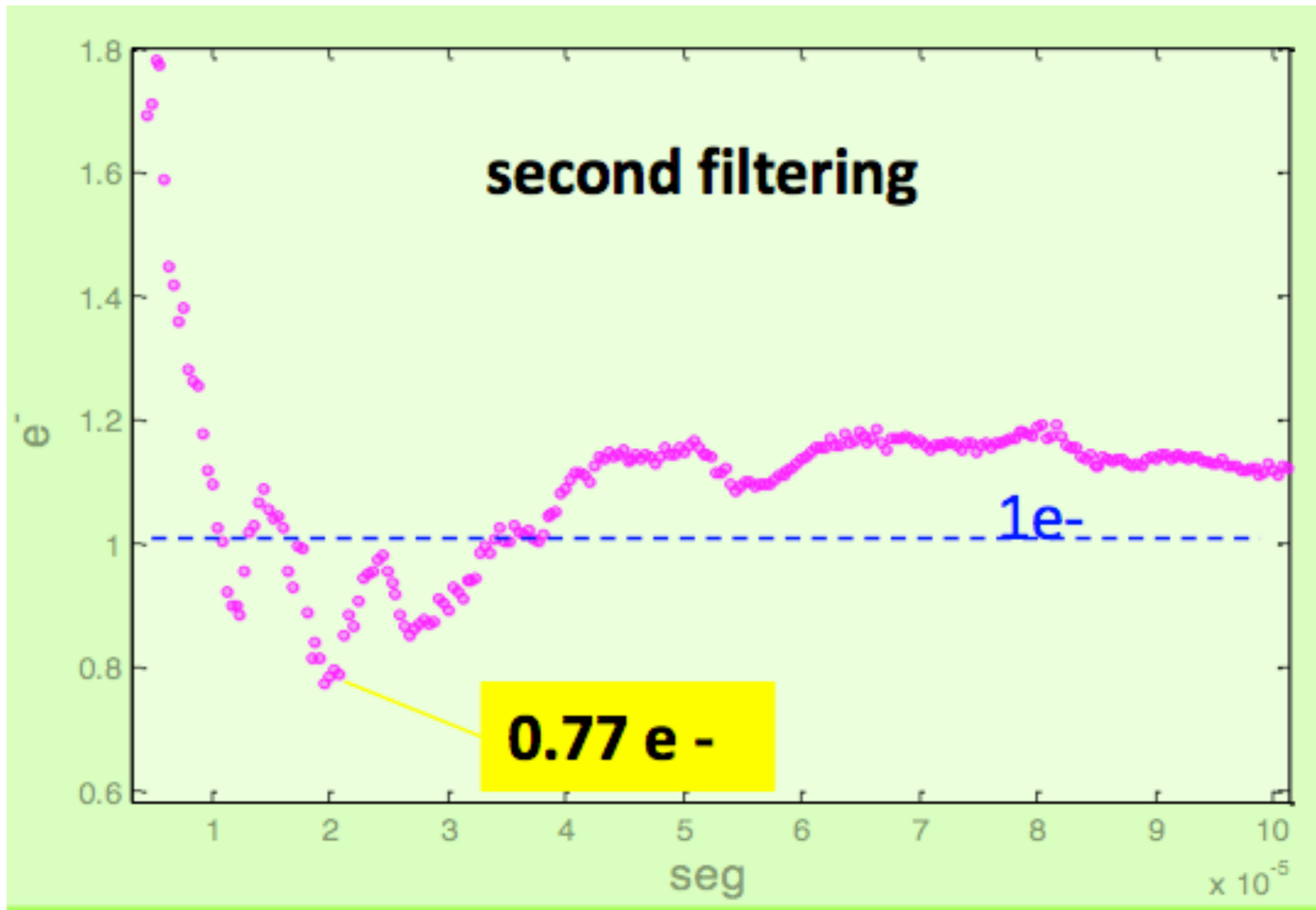
this is the low frequency stuff without jumps.



th



mps.



we can now reduce the noise to $0.77e-$, we need to implement this on DAMIC (G. Cancelo + international fellow student)